SRS   STANFORD RESEARCH SYSTEMS

MODEL SR715
MODEL SR720
LCR Meters

SAFETY AND PREPARATION FOR USE

WARNING

Dangerous voltages, capable of causing injury or death, are present in this instrument. Use extreme caution whenever the instrument cover is removed. Do not remove the cover while the unit is plugged into a live outlet.

CAUTION

This instrument may be damaged if operated with the LINE VOLTAGE SELECTOR set for the wrong AC line voltage or if the wrong fuse is installed.

LINE VOLTAGE SELECTION

The SR715/720 operates from a 100V, 120V, 220V, or 240V nominal AC power source having a line frequency of 50 or 60 Hz. Before connecting the power cord to a power source, verify that the LINE VOLTAGE SELECTOR card, located in the rear panel fuse holder, is set so that the correct AC input voltage value is visible.

Conversion to other AC input voltages requires a change in the fuse holder voltage card position and fuse value. Disconnect the power cord, open the fuse holder cover door and rotate the fuse-pull lever to remove the fuse. Remove the small printed circuit board and select the operating voltage by orienting the printed circuit board so that the desired voltage is visible when pushed firmly into its slot. Rotate the fuse-pull lever back into its normal position and insert the correct fuse into the fuse holder.

LINE FUSE

Verify that the correct line fuse is installed before connecting the line cord. For 100V/120V, use a 1/2 Amp fuse and for 220V/240V, use a 1/4 Amp fuse.

LINE CORD

The SR715/720 has a detachable, three-wire power cord for connection to the power source and to a protective ground. The exposed metal parts of the instrument are connected to the outlet ground to protect against electrical shock. Always use an outlet which has a properly connected protective ground.

BIAS VOLTAGE ON CAPACITORS

Verify that polarized capacitors are installed with the correct polarity before applying a bias voltage. Failure to do so can result in damage to the unit, the device under test, or possible injury. The SR715/720 fixture and remote fixtures are marked with '+' and '-' signs, or by red leads for the positive connectors. Capacitors charged by an external bias voltage should be discharged after making the measurement. A 40 volt external bias can charge a capacitor to a high enough voltage that it can cause injury if it is accidentally discharged. See the section on BIAS for more information on how to safely apply external bias voltage.

When connecting the external bias voltage to the unit, observe the correct polarity and make certain that the bias supply is floating (neither side is connected to ground). Be certain to use a supply current limited to 250 mA or less.

PROTECTION FUSES

In addition to the line fuse, the SR715/720 has two other protection fuses. The external bias fuse (3AG 0.25 A) is installed on the rear panel, next to the bias terminals. If unstable readings occur when making measurements with an external bias, check this fuse. The other fuse is an output protection fuse (2AG 0.25 A) located internally on the main PCB. If unstable or erratic readings occur or an 'outPut Err' (output err) occurs during self test, this fuse may be damaged. See the maintenance section for more information.

SERVICE

Do not attempt to service or adjust this instrument unless another person, capable of providing first aid or resuscitation, is present. Do not install substitute parts or perform any unauthorized modifications to this instrument. Contact the factory for instructions on how to return the instrument for authorized service and adjustment.

GENERAL INFORMATION

The SR715/720 LCR Meters are multifrequency impedance measuring instruments, capable of measuring resistance, capacitance or inductance over a range of more than 13 orders of magnitude. The SR720 has a basic accuracy of 0.05% and has 5 test frequencies. The SR715 has a basic accuracy of 0.2% and 4 test frequencies.

The LCR meters are controlled by a high speed microcontroller that operates the display, keypad, RS232 and GPIB computer interfaces, and handler interface, as well as setting measurement conditions and performing calculations. In addition, non-volatile storage is provided for 9 complete instrument settings.

SPECIFICATIONS

DISPLAY

Measurement Modes	Auto, R+Q, L+Q, C+D, C+R
Equivalent Circuit	Series or Parallel
Parameters Displayed	Value, Deviation, % Deviation or Bin Number. Deviation and % deviation are calculated from a stored relative value.
Averaging	2 - 10 Measurements
Measurement Range	R+Q: R 0.0001 Ω - 2000 MΩ Q 0.00001 - 50 L+Q: L 0.0001 µH - 99999 H Q 0.00001 - 50 C+D: C 0.0001 pF - 99999 µF D .00001 -10 C+R: C 0.0001 pF - 99999 µF R .00001 - 99999 kΩ

TEST CONDITIONS

Test Frequency	100 Hz, 120 Hz, 1 kHz, 10 kHz, 100 kHz (100 kHz - SR720 only). Frequency accurate to ±100ppm.
Drive Voltage	Preset Levels: 0.10, 0.25, and 1.0 Vrms. Vernier: 0.1 to 1.0 Vrms with 50 mV resolution.
Drive levels accuracy	±2%.
Measurement Rate	Slow, Medium, Fast: 2, 10, or 20 measurements per second at test frequencies of 1 kHz and above and about 0.6, 2.4, or 6 measurements per second at 100 Hz and 120 Hz.
Ranging	Auto or Manual
Triggering	Continuous, Manual, or Remote over RS232, GPIB or Handler Interface
Bias Voltage	Internal: 2.0 VDC ±2% External : 0 to +40 VDC (fused @ 0.25 A)

ACCURACY

Conditions	At least 30 minute warm up, 23 °C ± 5 °C.
Basic Accuracy	SR715: 0.20%
	SR720: 0.05%
	See the Accuracy section for detailed accuracy specifications.

The table below summarizes the typical use accuracy.

Accuracy	SR720	SR715
better than 1%	$0.125 \, \Omega < R < 16 \, M\Omega$	$0.143 \, \Omega < R < 14 \, M\Omega$
	$2.5 \, \mu H < L < 25 \, kH$	$2.9 \, \mu H < L < 22 \, kH$
	$1.25 \, pF < C < 12.8 \, mF$	$1.43 \, pF < C < 11.2 \, mF$
better than 5%	$21 \, m\Omega < R < 96 \, M\Omega$	$21 \, m\Omega < R < 94 \, M\Omega$
	$420 \, nH < L < 150 \, kH$	$426 \, nH < L < 150 \, kH$
	$0.21 \, pF < C < 77 \, mF$	$0.21 \, pF < C < 75 \, mF$

The following conditions apply:
1) 1.0, 0.5 or 0.25 V output voltage
2) Slow or medium measurement speed
3) Q and D < 0.1 for R and C
4) Q > 10 for L
5) 100 Hz, 120 Hz or 1 kHz test frequency for R
6) 100 Hz test frequency for L_{max} and C_{max}
7) 10 kHz test frequency for L_{min} and C_{min}

FEATURES

Fixture	4-Wire Kelvin fixture for radial leaded parts with adapters for axial leaded parts.
Protection	Protected up to 1 Joule of stored energy (for charged capacitors). Fused at 0.25 A output current for biased measurement.
Zeroing	Open and Short Circuit Compensation.
Compensation Limits	Short: $R < 20 \, \Omega$, $Z < 50 \, \Omega$
	Open: $Z > 10 \, k\Omega$
Binning	Up to 8 Pass Bins, QDR and General Fail Bins, all defined from the front panel or over the computer interfaces. Binning setups may be stored in non-volatile memory.
Self Test	Tests the ROM, CPU, Non-Volatile RAM, Clock Generator, A/D Converter, Internal Bias, Multiplier, Output Drive Circuitry, Gain Circuitry, and Source Resistances.
Store and Recall	Stores 9 Complete Instrument Setups. Recall 0 recalls Default Setup.
RS232 Interface	All instrument functions can be controlled or read over the interface.

GENERAL

Operating Conditions	0 - 50 °C, <85% relative humidity.
Power	20 Watts, 100/120/220/240 VAC, 50 or 60 Hz.
Dimensions (W x H x L)	13.5" x 4" x 14" (343 x 102 x 356 mm)
Weight	10 lbs (4.55 kg)
Warranty	One year parts and labor on materials and workmanship.

OPTIONS

GPIB / Handler Interface

Option 01 provides both an IEEE-488 interface and a Handler interface.

IEEE-488 Interface: All instrument functions can be controlled or read over the interface.

Handler/Sorter Interface: DB25 male connector provides output lines to indicate binning information and instrument status and an input trigger line. Output lines include 8 Pass Bins, QDR Fail Bin, General Fail Bin, Busy, and Bin Data Available. Output lines are Open Collector and are rated to 40 volts. The trigger input is negative edge triggered TTL and is protected to +/- 15 Volts.

SR726 Kelvin Clips

Provides connection to devices that are not easily accommodated in the fixture. Polarity is indicated for biased measurements. Connects to SR715/720 fixture.

SR727 SMD Tweezers

Provides connection to Surface Mount Device parts. Polarity is indicated for biased measurements. Connects to SR715/720 fixture.

SR728 BNC Fixture Adapter

Provides a means to connect a remote fixture or other device to the SR715/720. Connects to SR715/720 fixture and has four 1 meter BNC cables. Polarity is indicated for biased measurements.

BASIC OPERATION

This section is designed to help the user begin making measurements with the SR715/720 LCR meter and to familiarize them with some of its features. For more information on the different features, see the operations section.

To operate the SR715/720, first verify that the correct line voltage has been selected on the power entry module on the rear panel (See page 1-3). Verify that no parts are in the fixture; the unit's self test routines will fail if any components are in the test fixture. After connecting the line cord to the power entry module, switch on the power switch, located on the rear right hand side of the unit. The unit will display the ROM version on the left display and the serial number on the right display for about 3 seconds. Next, the unit will begin its self test procedure. If all tests are OK, 'tESt PASS' will be displayed. See the Troubleshooting section if the self test fails. Press [Recall] [0] [ENTER], to recall the default setup. This will set the unit as follows:

Parameter	AUTO
Frequency	1 kHz
Drive Voltage	1.0 Vrms
Bias	OFF
Measurement Rate	SLOW
Averaging	OFF
Range Hold	OFF
Equivalent Circuit	SERIES
Display	VALUE
Trigger Mode	CONT
Binning	OFF

At this point a part can be placed in the fixture and measurements can be made. The unit will automatically decide which type of component is in the fixture (R, C or L), change to the correct range, and display the part value with the correct units. If any of the test conditions need to be changed for a measurement, press the appropriate keys. Most functions are easy to change, but if more information is needed, see the operating section.

The SR715/720 comes with a built in fixture for measuring radial leaded components, like most capacitors, and adapters for measuring axial leaded components, like most resistors. To measure a radial leaded component, remove any adapters and put one lead of the component in each side of the fixture. To measure an axial leaded component, first install the fixture adapters. Put the adapters on in the middle of each side of the fixture, and then slide them until they are separated by the appropriate distance. Insert the one lead of the component into each side of the fixture.

After changing the fixture configuration, it is a good idea to perform an open and short circuit calibration. See the operation section for instructions. If the component leads are excessively dirty or are coated with wax, clean them before inserting them in the fixture. The fixture contacts will usually make contact through coatings, but can eventually get gummed up.

If biased measurements are being made on capacitors, **be certain that the part is installed with the correct polarity,** as marked on the unit.

What is a passive device?

All non-ideal passive devices (resistors, inductors and capacitors) can be modeled as a real component (resistor) either in series or in parallel with a reactive component (capacitance or inductance). The impedance of these components change as a function of frequency. The series and parallel models are mathematically equivalent and can be transformed back and forth with the equations shown below.

Usually one model is a better representation of the device under operating conditions. The most accurate model depends on the device and the operating frequency. Certain devices are tested under conditions defined by the manufacturer or industry standard. For example, electrolytic capacitors are often measured in series at 120 Hz in the C+R mode, so the ESR (equivalent series resistance) can be measured.
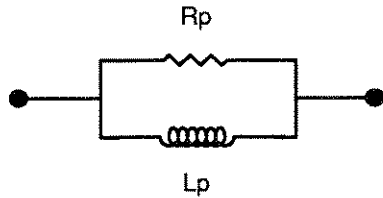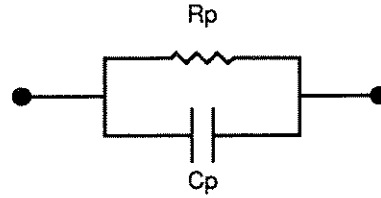
Series and Parallel circuit models

L+R

Rs   Ls

Series

Rp

Lp

Parallel

C+R

Rs   Cs

Series

Rp

Cp
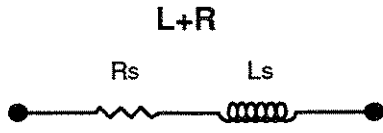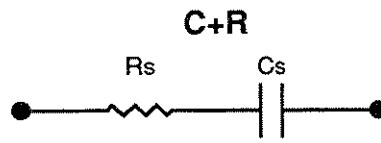
Parallel

$$Z_s = R_s + j\omega L_s = R_s(1 + jQ) = \omega L_s\left(\frac{1}{Q} + j\right)$$

$$Z_p = \frac{j\omega L_p R_p}{R_p + j\omega L_p} = \frac{R_p(1 + jQ)}{1 + Q^2}$$

$$Q = \frac{R_p}{\omega L_p} = \frac{\omega L_s}{R_s} \qquad Q = \frac{1}{D}$$

$$L_s = \frac{Q^2}{1 + Q^2}L_p \qquad R_s = \frac{\omega L_s}{Q} \qquad R_p = Q\omega L_p$$

$$R_p = \frac{1}{G_p} \qquad B_p = -\frac{1}{\omega L_p}$$

$$Y = G_p - \frac{j}{\omega L_p}$$

$$Z_s = R_s - j\frac{1}{\omega C_s} = \frac{1}{\omega C_s}(D - j) = R_s\left(1 - \frac{j}{D}\right)$$

$$Z_p = \frac{R_p}{1 + j\omega R_p C_p} = \frac{D^2 R_p + \frac{1}{j\omega C_p}}{1 + D^2}$$

$$D = \omega R_s C_s = \frac{1}{\omega R_p C_p} \qquad D = \frac{1}{Q}$$

$$C_s = \left(1 + D^2\right)C_p \qquad R_s = \frac{D^2}{1 + D^2}R_p$$

$$R_p = \frac{1}{G_p} \qquad B_p = \omega C_p$$

$$Y = G_p + j\omega C_p$$

R_s in capacitors is often referred to as ESR or equivalent series resistance. It includes things like dielectric absorption in addition to the ohmic losses due to the leads. It is often listed on data sheets for electrolytic capacitors used in switching power supplies. At high frequencies, the ESR is the limiting factor in the performance of the capacitor.

The quality factor, Q, is the ratio of the imaginary impedance to the real impedance. For inductors, a high Q indicates a more reactively pure component. A low Q indicates a nearly pure resistor. Q varies with frequency. Q is commonly used to describe inductors. With resistors, often all that is stated is that the resistor has low inductance.

The dissipation factor, D, is equal to 1/Q and is the ratio of the real impedance to the imaginary impedance. A low D indicates a nearly pure capacitor. D is commonly used when describing capacitors of all types.

Typical measurement setups

The table below lists suggested test conditions for various types of components. This is by no means the only set of conditions for measuring, but is a good general "rule of thumb".

Setups For Measuring Typical Parts

| Compoment Type	Value	Parameter Type	Equivalent Circuit	Frequency
Unknown:	any	Auto	series	1 kHz
Resistors:	< 1 kΩ	R+Q	series	1 kHz
	> 1 kΩ	R+Q	series	100 or 120 Hz
Inductors:	< 10 µH	L+Q	series	100 kHz
	10 µH - 1 mH	L+Q	series	10 kHz
	1 mH - 1 H	L+Q	series	1 kHz
	> 1 H	L+Q	series	100 or 120 Hz
Capacitors:	<10 pF	C+D	parallel	10 kHz
	10 pF - 400 pF	C+D	series or parallel	10 kHZ
	400 pF - 1 µF	C+D	series	1 kHz
	> 1 µF	C+R or C+D	series	100 or 120 Hz

How the SR715/720 Works

The SR715/720 measures the impedance of a component by measuring the voltage across the part and the current through it. This is done for both the real and imaginary (90° phase shifted) components of the signals. The complex ratio of voltage to current is equal to the complex impedance. The processor calculates the various parameters that are displayed, R, C, L, Q or D.

The voltage across the part is generated by Vs. Both the amplitude and frequency of Vs can be set. This voltage is applied to the device under test (DUT) through source resistance Rs, which varies according to the measurement range. The current flows to the virtual ground of A1, and through Rr,

the current conversion resistor. The output of A1 provides a signal proportional to the current, I x Rr. The voltage across the DUT is measured with a separate signal path providing a 4-wire Kelvin connection.

The real and imaginary signals are obtained by multiplying the voltage and current signals with a reference signal in phase with Vs and one shifted 90 degrees from Vs. These signals are measured by an integrating A/D converter which is read by the microprocessor. These values are corrected by calibration factors, converted to impedances and finally converted to the appropriate parameters for display by the processor.
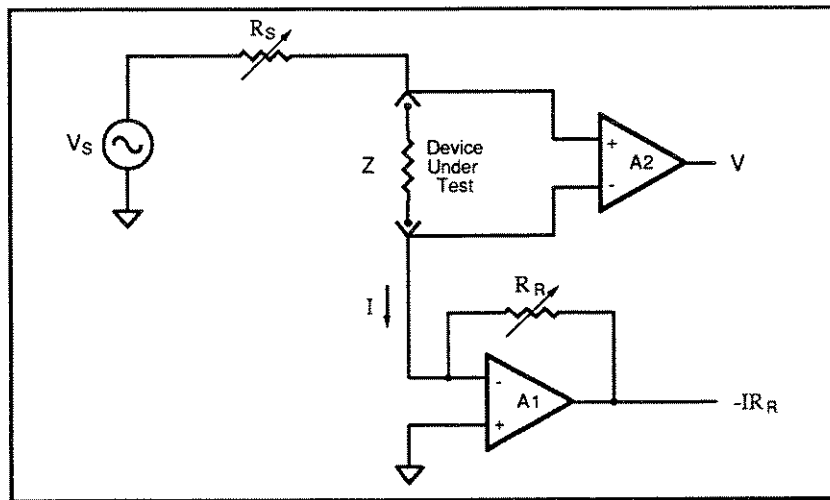
COMMAND LIST

VARIABLES	i,j	Integers
	x	Real Number

MEASUREMENT SETUP

$STL(?) {i}	Set (query) settling time to between i=2 and i=99 milliseconds.
AVGM(?) {i}	Set (query) averaging on (i=1) or off (i=0).
BIAS(?) {i}	Set (query) DC bias to internal (i=1), external (i=2), or off (i=0).
CIRC(?) {i}	Set (query) equivalent circuit to series (i=0) or parallel(i=1).
CONV(?) {i}	Set (query) constant voltage mode on (i=1) or off (i=0).
FREQ(?) {i}	Set (query) drive frequency to 100Hz(0), 120Hz(1), 1kHz(2), 10kHz(3) or 100kHz(4).
MMOD(?) {i}	Set (query) measurement mode to continuous (i=0) or triggered (i=1).
NAVG(?) {i}	Set (query) number of measurements to be averaged from i=2 to i=10.
PMOD(?) {i}	Set (query) parameter mode to Auto(0), R+Q(1), L+Q(2), C+D(3), or C+R(4).
RATE(?) {i}	Set (query) measurement rate to Fast(0), Medium(1) or Slow(2).
RNGE(?) {i}	Set (query) measurement range to 100kΩ(0), 6.4kΩ(1), 400Ω,(2) or 25Ω(3).
RNGH(?) {i}	Set (query) range hold to enabled (i=1) or disabled (i=0).
VOLT(?) {x}	Set (query) drive voltage to $0.1V \leq x \leq 1.00V$ with 0.05V resolution.

MEASUREMENT CONTROL

PREL(?) {x}	Set (query) nominal parameter value for deviation and %deviation to x (Ω,F,H).
STRT	Starts a measurement.
STOP	Stops the current measurement.
*TRG	Same as STRT.

MEASUREMENT RESULT

OUTF(?) {i}	Set (query) the output format to verbose (0) or concise (1) ASCII, or verbose (2) or concise (2) binary.
XALL?	Returns major and minor parameters plus bin number.
XBIN?	Returns bin number of current measurement.
XDLT?	Returns deviation between major parameter and nominal value.
XMAJ?	Returns value of the major parameter.
XMIN?	Returns value of the minor parameter.
XPCT?	Returns percent deviation between major parameter and nominal value.

BINNING

BCLR	Clears nominal values and limits for all bins. All bins are closed.
BING(?) {i}	Set (query) binning to enabled (i=1) or disabled (i=0).
BLIM(?) i,j {,x}	Set (query) upper (i=0) or lower (i=1) limit of bin j (0-7) to x%.
BNOM(?) i {,x}	Set nominal value of bin i to x.

SETUP CONTROL

*IDN?	Returns the SR715/720 identification string.
*OPC(?)	Set bit in Standard Event Status byte when measurement complete.
*RCL i	Recall setting i.
*RST	Reset unit to default configuration.
*SAV i	Save current setup as setting i.
*WAI	Wait until all measurements are completed before proceeding.

STATUS

|	
*CLS	Clear all status registers.
*ESE(?) {i}	Set (query) the Standard Event Status Byte Enable register to value i (0-255).
*ESR? {i}	Query Standard Status byte. If i is included, only bit i is queried.
*PSC(?) {i}	Set (query) power-on status clear bit to clear (i=1) or maintain (i=0) status values.
*SRE(?) {i}	Set (query) the Serial Poll Enable register to value i (0-255).
*STB? {i}	Query Serial Poll status byte. If i is included, only bit i is queried.
SENA(?) {i}	Set (query) LCR Status Enable register to value i (0-255).
STAT? {i}	Query LCR Status byte. If i is included, only bit i is queried.

STATUS BYTE DEFINITIONS

SERIAL POLL STATUS BYTE

bit	name	usage
0	Ready	The SR7XX is ready to perform a measurement.
1	unused	
2	unused	
3	LCR	An unmasked bit in the LCR status register has been set.
4	MAV	The GPIB output queue is non-empty
5	ESB	An unmasked bit in the standard status byte has been set.
6	RQS/MSS	SRQ (Service Request)bit.
7	No Command	There are no unexecuted commands in the input queue

STANDARD EVENT STATUS BYTE

bit	name	usage
0	OPC	Set by the OPC command when all measurements are complete
1	unused	
2	Query Error	Set on output queue overflow (Too many responses waiting to be transmitted.)
3	unused	
4	Execution err	Set by an out of range parameter, or non-completion of some command due a condition such as an incorrect operating mode.
5	Command err	Set by a command syntax error, or unrecognized command
6	URQ	Set by any key press
7	PON	Set by power on

LCR STATUS BYTE

bit	name	usage
0	Math Error	Set on a floating point error.
1	A/D Error	Set when an A/D conversion fails.
2	Overload	Set when the gain stage is overloaded.
3	Underrange	Set when a measurement is below the nominal range of values for the present range.
4	Overrange	Set when a measurement is above the nominal range of values for the present range.
5	Out of Range	Set when the unit is unable to make a valid measurement on the current range.
6	unused	
7	mem err	the stored settings were invalid on power up.

SR715/720 LCR Meters

This section of the manual provides an overall view of the SR715/720. For detailed operating information on specific features, see the Operating and Programming sections.
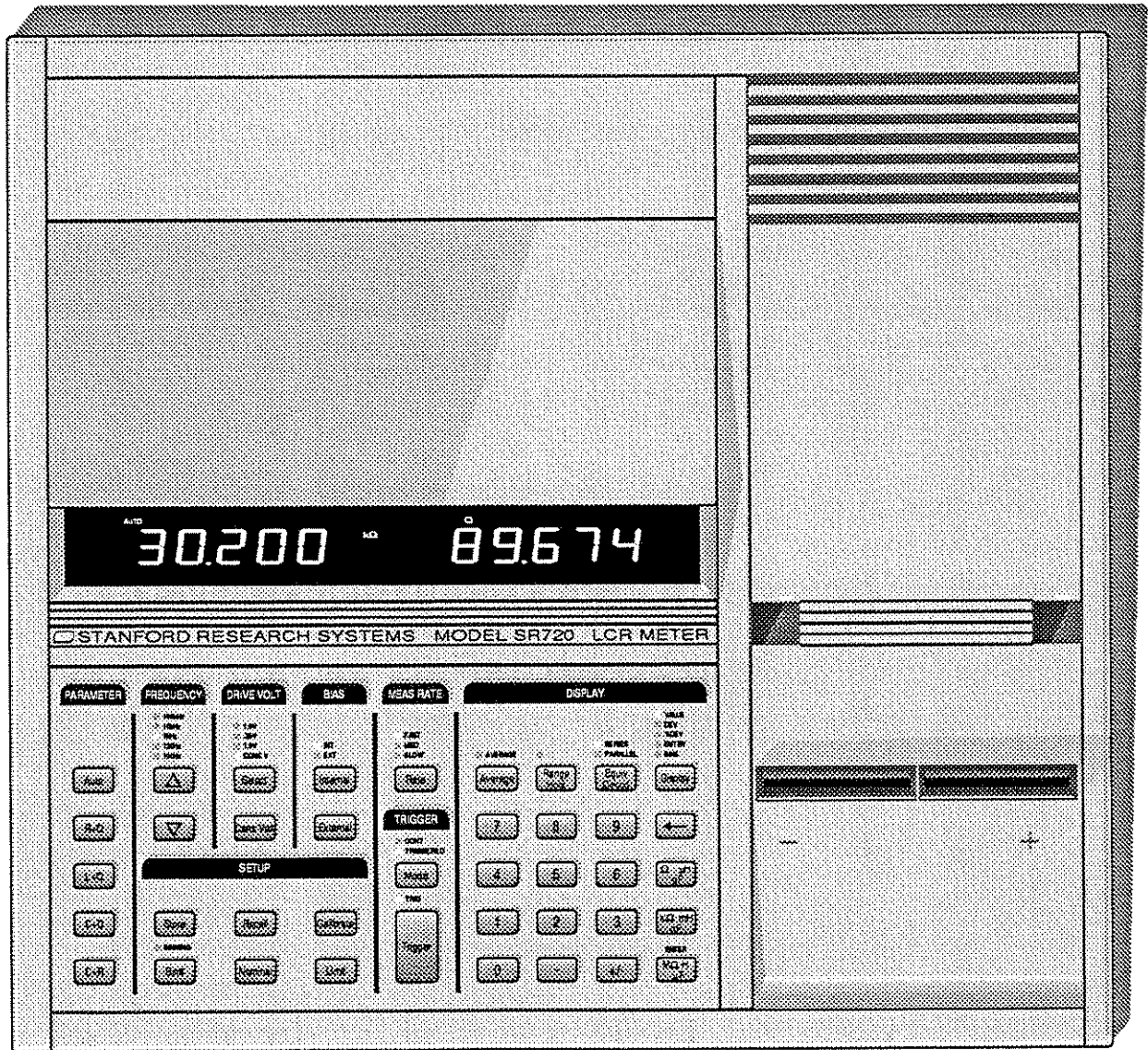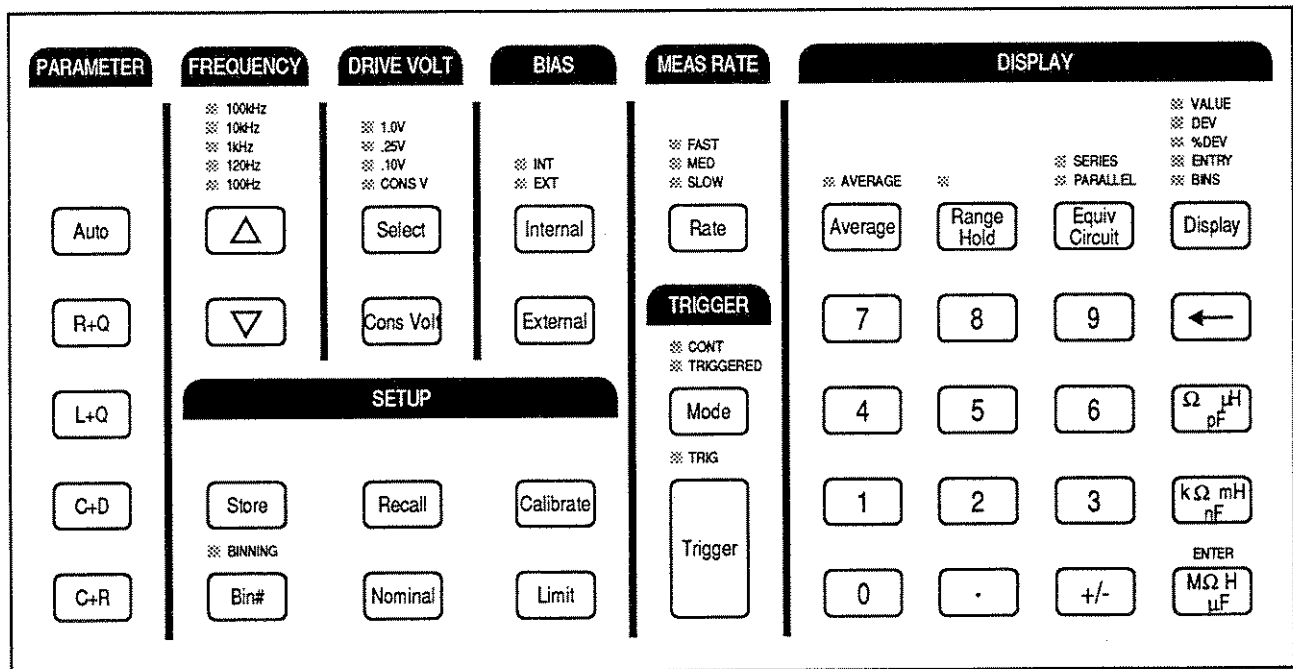
Display
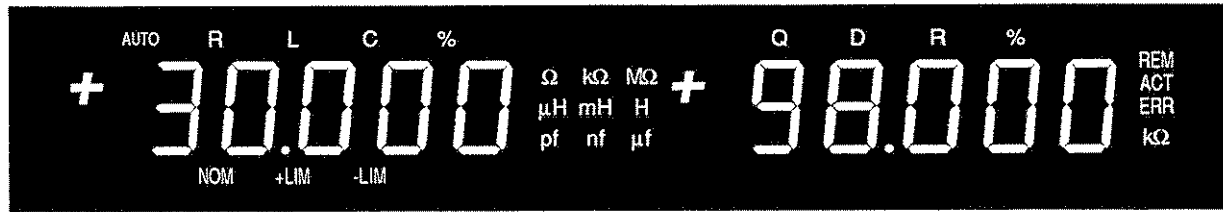
The LED display shows measured values, entered parameters, instrument status, and user messages. There are two 5 digit LED displays and 25 indicator LEDs. When making normal measurements, the major parameter (L, C, or R) is shown on the left display and the appropriate minor parameter (Q, D or R) is shown on the right display. The number of displayed digits and the location of the decimal points are automatically adjusted according to the range and resolution. The measured parameters (L, C, or R and Q, D, or R) are indicated by the LEDs above each numeric display. If the AUTO LED is also on, the unit is in the auto parameter mode. The % LED indicates that the measurement is displayed as a relative deviation from an entered nominal value. Units are indicated by the LEDs located between the two displays: Ω, kΩ, MΩ, μH, mH, H, pF, nF or μF. The minor parameter is dimensionless (Q and D) or has the units of Ohms for resistance, unless the kΩ LED on the right is on. Status information (REM, ACT and ERR) is shown to the right of the minor parameter. Beneath the major parameter display are indicators for entering binning values, NOMinal, +LIMit and -LIMit.

Keypad

PARAMETER | FREQUENCY | DRIVE VOLT | BIAS | MEAS RATE | DISPLAY

100kHz
10kHz
1kHz
120Hz
100Hz

1.0V
.25V
.10V
CONS V

INT
EXT

FAST
MED
SLOW

AVERAGE

SERIES
PARALLEL

VALUE
DEV
%DEV
ENTRY
BINS

[Auto] [△] [Select] [Internal] [Rate] [Average] [Range Hold] [Equiv Circuit] [Display]

TRIGGER

CONT
TRIGGERED

[R+Q] [▽] [Cons Volt] [External] [7] [8] [9] [←]

SETUP

[Mode]

[L+Q] [4] [5] [6] [Ω μH pF]

TRIG

[C+D] [Store] [Recall] [Calibrate] [1] [2] [3] [kΩ mH nF]

BINNING

[Trigger] ENTER

[C+R] [Bin#] [Nominal] [Limit] [0] [.] [+/-] [MΩ H μF]

The keypad is used to select measurement conditions and to enter values. LEDs indicate the actual measurement conditions.

PARAMETER
The [R+Q], [L+Q], [C+D], [C+R], and [AUTO] keys select the parameter being measured. The selected parameter pair is indicated above the major and minor parameters in the display. If AUTO is selected, the unit will select the most appropriate parameter pair and turn on the AUTO LED above the major parameter display.

FREQUENCY
The [UP Arrow] and [DOWN Arrow] keys select one of the following output frequencies: 100 Hz, 120 Hz, 1 kHz, 10 kHz or 100 kHz (SR720 only). The LEDs indicate the selected frequency.

DRIVE VOLT
The [Select] key cycles through the three output drive voltages, 0.1 V, 0.25 V and 1.0 V. The selected voltage is indicated by the LEDs. If no LED is on then the output drive voltage is in the vernier mode.

The [Cons Volt] key places the unit in the constant voltage mode.

BIAS
[Internal] selects a 2.0 VDC internal bias. [External] selects an external bias source. Pressing the active key ([Internal] when internal bias is already selected or [External] when external is selected) turns the bias off.

Note that the bias is used only for capacitance measurements. Pressing either of these keys in any other mode, including the auto mode, will display the error "bias for C".

MEAS RATE
The [Rate] key selects a slow, medium or fast measurement. These rates correspond to 2, 10, or 20 measurements per second at measurement frequencies of 1 kHz or higher.

AVERAGE
The [Average] key places the unit in the averaging mode. Pressing it a second time returns the unit to the non-averaged mode. The number of readings averaged is set to between 2 and 10 from the entry display.

RANGE HOLD
[Range Hold] holds the unit in its current measurement range. Pressing the key a second time

returns the unit to autoranging or normal mode. The range can also be entered with the numeric keys in the entry display.

EQUIV CIRCUIT
The [Equiv Circuit] key selects between a series or parallel equivalent circuit model of the component being measured.

DISPLAY
The [Display] key selects the parameter on the display. Pressing [Display] cycles through the following display types.

VALUE   the value being measured

DEV   the deviation of the value from an entered value

%DEV   the percent deviation from the nominal

ENTRY   for entering parameter values

BINS   the bin number when binning is enabled

Certain displays are not accessible unless data has been entered. For example DEV and %DEV are not available unless a nominal value has already been entered. Also, BINS is not available unless binning data has been entered.

<-
The [<-] (backspace) key is used for correcting mistakes when entering numeric data. The [<-] also serves as the LOCAL key.

If the [<-] is held down when the unit is powered on, the instrument setting revert to the factory set defaults.

ENTER KEYS
[Ω, µH, pF] [kΩ, mH, nF] [MΩ, H, µF]
The three enter keys are used when entering numeric parameters in the entry display, such as nominal values of R, C, or L. The [MΩ, H, µF] key acts as a general purpose [ENTER] key for parameters with units not listed on any key, such as percent. This key is labelled on the panel above the key.

NUMERIC KEYS [0]..[9], [.], [+/-]
The numeric keys enter parameters and are only active when the unit is in the entry display.

STORE and RECALL
The unit can store up to 9 complete instrument setups in non-volatile memory. To store the present configuration as setup #n, press [Store] [n] [ENTER] where n ranges from 1 through 9. To recall an instrument configuration, press [Recall] [n] [ENTER]. Recall 0 returns the instrument to its default values.

CALIBRATE
The [Calibrate] key allows access to a series of calibration features and special configurable parameters, including open/short circuit calibration, standard calibration, settling time, vernier output drive amplitude, and the internal self tests.

BIN#, NOMINAL and LIMIT
These keys are used to enter binning parameters. The BINNING LED is on when binning is enabled and the optional handler is active.

TRIGGER and MODE
The [Mode] key selects between continuous (CONT), or triggered measurements.
Measurements are triggered by the [Trigger] key, the handler interface or either of the computer interfaces.
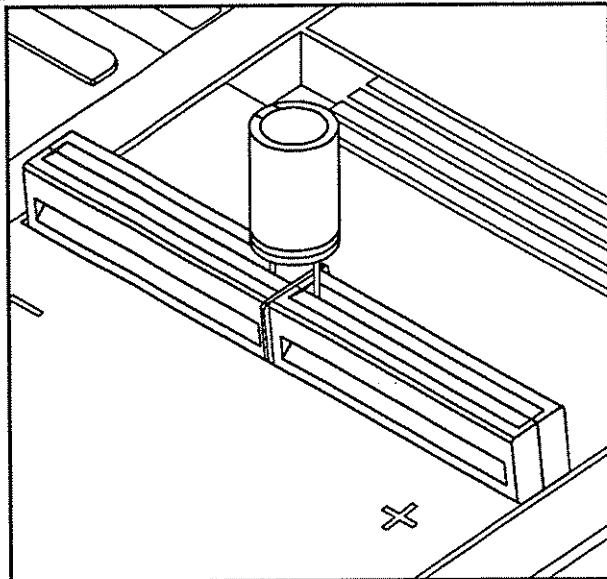
Fixture

A versatile test fixture is provided with the SR715/720 that provides a 4 wire Kelvin connection to most types of leaded devices. (A Kelvin connection uses two wires to carry the test current to and from the device and two independent wires to sense the voltage across the device.) This prevents the voltage drop in the current carrying wires from affecting the voltage measurement.

Radial leaded components (where the leads are on the same side) are simply inserted into the test fixture, one lead in each side.

Axial leaded devices (leads at opposite ends), require the use of the axial fixture adapters.

Surface mount (SMD) devices or components with large or unusually shaped leads can be measures with SMD tweezers or Kelvin Clips. A BNC adapter is available for interfacing to remote fixtures.

If the device leads are dirty or coated with wax, clean them before inserting them in the fixture. See the maintenance section for information about cleaning the fixture.

Radial Fixture (with part)
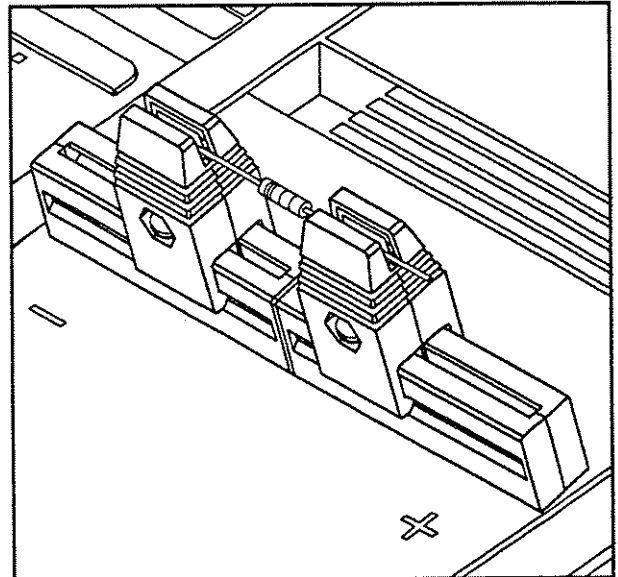
Axial Fixture (with part)

Rear Panel

POWER ENTRY MODULE
The Power Entry Module is used to fuse the line power, select the input voltage, and filter high frequency electrical noise.

POWER SWITCH
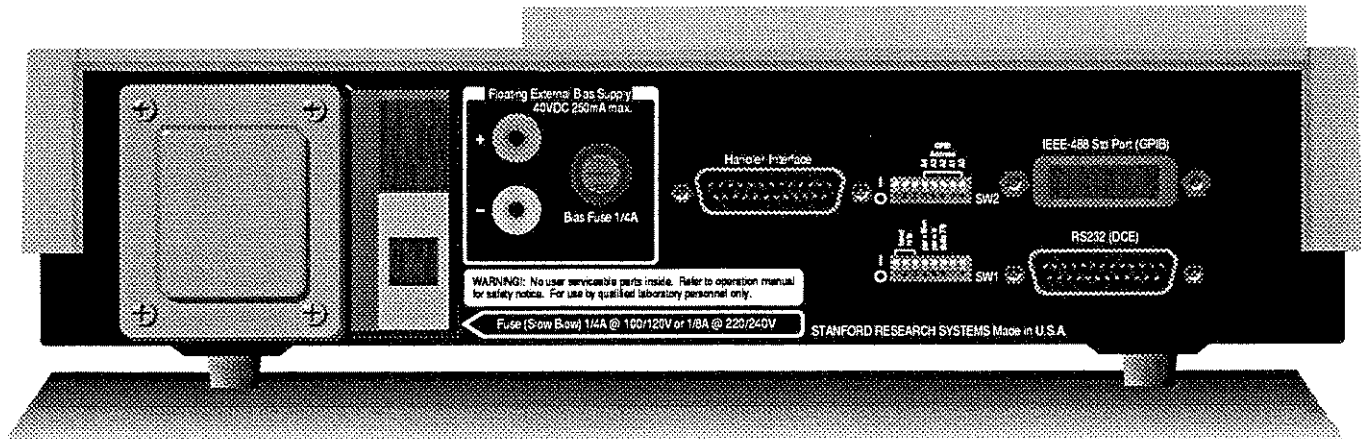The power switch is located on the rear right side of the unit. Depressing the front side of the switch turns the unit on.

EXTERNAL BIAS INPUT
The two banana plugs are the input connections for the external bias voltage. The bias supply must be floating and well filtered. **Neither side can be ground referenced**. The applied voltage must be 40 VDC or less and current limited to 250 mA max.

EXTERNAL BIAS FUSE
Protects the external bias input from currents greater than 250 mA.

RS232 DB25 CONNECTOR
This connector allows for computer control of the unit over an RS232 interface. The connector is configured as a DCE (transmit on pin 3, receive on pin 2). To connect the unit to a Personal Computer serial adapter, which is usually a DTE, use a straight thru serial cable. See the programming section for more information.

SW1
These switches set baud rate, parity and word length for the RS232 interface. See the programming section for details on setting the interface.

HANDLER INTERFACE (OPTION 01)
This provides control lines to a component handler for sorting. The interface has an input trigger line and output lines indicating bin data available, busy and 10 separate bins. The connector is a male DB25. See the Handler section for more detail.

IEEE-488 (GPIB) CONNECTOR (OPTION 01)
This connector allows for computer control of the unit over the GPIB or IEEE-488 interface. See the programming section for more information.

SW2 (OPTION 01)
These switches set the instrument address for the GPIB interface. See the programming section for detail on how to set up the interface.

DISPLAY

The SR715/720 displays both major and minor parameters simultaneously. In addition to the parameter selection, the display type may also be specified. This allows results to be shown in engineering units, deviation from a specified nominal value, or binned for sorting purposes. The display also shows values entered from the keyboard while specifying the nominal value or bin limits. The status LED's indicate remote programming status information.

DISPLAYED PARAMETERS

The Parameter keys ([R+Q], [L+Q], [C+D], [C+R], and [AUTO]) determine the measurement type and the displayed parameters. The selected parameters are indicated above the two 5 digit displays.

R+Q   Resistance is shown on the major parameter (left) display and the quality factor, Q, on the minor parameter (right) display. The resistance is either the equivalent series or parallel resistance of the device under test. The units of resistance are Ω, kΩ, or MΩ. Q is the ratio of the imaginary part of the impedance to the real part of the impedance and is dimensionless. Q is the same for both series and parallel representations. If Q is positive, the reactive component of the device under test is inductive. If Q is negative, the reactive component is capacitive.

L+Q   Inductance is shown on the major parameter (left) display and the quality factor, Q, on the minor parameter (right) display. The inductance is either the equivalent series or parallel inductance of the device under test. The units of inductance are μH, mH or H. Q is the ratio of the imaginary part of the impedance to the real part of the impedance. Q is dimensionless and the same for both series and parallel representations. If the major parameter (inductance) is negative, then the part under test is capacitive.

C+D   Capacitance is shown on the major parameter (left) display and the dissipation factor, D, is shown on the minor parameter (right) display. The capacitance is either the equivalent series or parallel capacitance of the device under test. The units of capacitance are pF, nF, or μF. D is the ratio of the real part of the impedance to the imaginary part of the impedance, or 1/Q. A good capacitor has a large C (imaginary) and a small R (real) and thus a low D. If the major parameter (capacitance) is negative, then the part under test is inductive.

C+R   Capacitance is shown on the major parameter (left) display. The equivalent series or parallel resistance is shown on the minor parameter (right) display. The units for resistance are Ω unless the kΩ LED to the right of the minor parameter display is on.

AUTO   The SR715/720 determines which component model is the most accurate representation of the device under test and chooses the appropriate parameter pair. The determination is made as follows:
If $|Q| < 0.125$ the unit selects R+Q.
If $Q > +0.125$ the unit selects L+Q.
If $Q < -0.125$ and the unit is in the series mode, it selects C+R.
If $Q < -0.125$ and the unit is in the parallel mode, it selects C+D.

SERIES and PARALLEL EQUIVALENT CIRCUITS

Any non-ideal component can be represented as a resistive component either in series or in parallel with a reactive component. Depending upon the characteristics of the component and the measurement frequency, either the series or parallel model will be the more accurate model. The more ideal a component is, the less the two models differ. However, as Q for inductors decreases towards 10 and Q for resistors or D for capacitors increases towards 0.1, the series and parallel values begin to diverge. In general, most parts are best approximated by the series model. Manufacturers often specify which representation should be used when testing their devices. MIL or industry standards also specify test conditions.

The [Equiv Circuit] key toggles between the two equivalent circuit models. The SERIES or PARALLEL LEDs indicate which model is active. For the series model, the left display shows the series resistance, inductance, or capacitance (for R+Q, L+Q, C+D and C+R). The right display will show the quality factor Q, the dissipation factor D, or the series resistance. For the parallel model, the left display shows the parallel equivalents of the major parameters (R, L, or C) and the right display shows Q, D, or the parallel resistance. Q and D are the same for both the parallel and series models.

DISPLAY TYPES

The [Display] key cycles through the five different display types. To cycle between the different displays, press the [Display] key repeatedly until the appropriate indicator LED is on. Some of the display types are not enabled unless the instrument is set appropriately. For example, only the Value and Entry displays are enabled when the instrument is in the AUTO mode.

VALUE   The value display shows the value of the component being measured. The type of component is indicated by the LEDs above the display (R+Q, L+Q, C+D, C+R). The units of each display are indicated by the unit LEDs to the right of the each display. The AUTO LED indicates that the auto select parameter (AUTO) mode is active. The Value display is enabled under all conditions.

DEV   The DEV, or deviation display, shows the difference between the component being measured and a previously entered relative value (display = measured value - relative value). This is useful for measuring small variations in component values. The DEV display is disabled if the unit is in AUTO mode or if no nominal value has been entered. To use the DEV display, first enter a nominal value (see below), then press the display key until the DEV LED is on. Negative readings mean that the measured value is smaller than the nominal value. Positive readings mean the measured value is larger than the nominal value.

Entering a Nominal Value
To enter a nominal value, press the [Display] key until the ENTRY display is selected. Next, press the appropriate parameter key, [R+Q] for nominal resistance values, [L+Q] for nominal inductance values, and either [C+D] or [C+R] for nominal capacitance values. The appropriate parameter LEDs will turn on and the present nominal value (or the default value) will appear in the left display. The right display will be blank. Enter the new nominal value using the numeric keys and one of the three enter keys [Ω,µH,pF], [kΩ,mH,nF], or [MΩ,H,µF].

%DEV   The %DEV, or percent deviation display, shows the % difference between the component being measured and a previously entered nominal value (display = 100 x {measured value - nominal value} / nominal value). Percentages are displayed to 0.1%. As with the DEV display this display is disabled if the unit is in

AUTO mode or if no nominal value has been previously entered. To enter a nominal value, follow the procedure described above.

ENTRY   The ENTRY display allows entry of nominal values, measurement conditions, and calibration data. To view this display, press the [Display] key until the ENTRY LED is on. If an out of range or incorrect value is entered, the unit will beep and display 'rAnGE Error' (range error) and not accept the value. The ENTRY display is enabled under all conditions.

BINS   The BINS display shows the bin number that a component falls into when binning is enabled. The display is disabled unless binning information has already been entered. The BINS display is also disabled when the unit is in the AUTO mode. To view the BINS display, first enter binning information and then press the [Display] key until the BINS LED is on. See the section on binning for more information.

AVERAGE   The AVERAGE display shows the arithmetic average of two to ten measurements. Averaging improves accuracy by cancelling out random errors and noise. This is useful for measurements at the extreme end of a measurement range or with low output signal levels. The number of measurements to be averaged is set in the ENTRY display. From the ENTRY display, press the [Average] key. The unit will display AvG in the left display and the present number of averages in the right display. Set the desired number of averages (2 thru 10) and press the [ENTER] ([MΩ,H,µF]) key. Return to the desired display type using the [Display] key. Pressing the [Average] key toggles between averaging enabled and disabled. The AVERAGE LED indicates that averaging is enabled. AVERAGE works for all display types, including binning. In the BINS display, the bin number displayed is the bin number of an average of several measurements, NOT the average bin number.

STATUS

These LEDs indicate the computer interface status. REM (remote) indicates that the unit is under remote interface control (front panel inactive). ACT (activity) indicates the computer interface is active. ERR (error) indicates that a command sent to the instrument contained an error.

BINNING

The NOM, +LIM and -LIM LEDs indicate which parameter is being entered while configuring the SR715/720 for binning. See the section on binning for more details.

TEST CONDITIONS

DEFAULT CONDITIONS

If the back space key [<-] is held down while turning on the unit, it will be set to the default setup shown below. **Any user calibrations are lost and factory calibrations are used.** Using [Recall] [0] [ENTER] will set the unit to the conditions below **without** disturbing any user calibration values.

Parameter	AUTO
Frequency	1kHz
Drive Voltage	1.0V
Bias	OFF
Measurement Rate	SLOW
Averaging	OFF
Range Hold	OFF
Equivalent Circuit	SERIES
Display	VALUE
Trigger Mode	CONT
Binning	OFF

SETTING TEST CONDITIONS

Test conditions are set two ways. Most of the major test conditions are set using a direct key press. These conditions have dedicated keys that change their values or settings. Other conditions are set through the ENTRY display, including the number of averages, range, and relative values for deviation measurements. To adjust these conditions, use the [Display] key to select the ENTRY display and press the key of the parameter to be changed. A message indicating which parameter has been selected will appear on the left display and the present value of the parameter will be shown on the right display. Input the new value using the numeric keys and use the unit keys or the [ENTER] key to enter the value. Return to the desired display with the [Display] key. If an illegal value is entered when changing the test conditions, the unit will beep and display 'rAnGE Error'. If this occurs the unit will disregard the entry and allow another value to be entered.

The [Calibrate] key is used to access a series of less often used functions. They are 'vtESt' (vernier test voltage), 'SEttL' (settling time), 'nuLL cAL' (null or open and short circuit cal) and 'SELF tESt' (self test). To access these functions, press the [Calibrate] key until the desired function appears. A message will appear along with the present value of that parameter. The new value is entered in the same manner as with the ENTRY functions.

|	
FREQUENCY	There are five selectable frequencies for the SR720 (four for the SR715): 100 Hz, 120 Hz, 1.0 kHz, 10 kHz, and 100 kHz (SR720 only). The output frequency is accurate to 100ppm (0.01%). Frequencies are set by pressing either the [UP Arrow] or [DOWN Arrow] key in the FREQUENCY section until the desired frequency LED is on. If the unit is in range hold on range 0, the 100 kHz frequency is disabled. If 100 kHz is selected while in range 0, the unit will beep and a 'r-f Error' (range - frequency error) will occur.
OUTPUT VOLTAGE	There are three primary output drive voltages that can be selected as well as a vernier setting with 50mV resolution. The primary voltage levels are 0.10 Vrms, 0.25 Vrms and 1.0 Vrms. The vernier settings range from 0.1 Vrms to 1.0 Vrms.

The accuracy of the output voltage levels is 2 %. The primary output levels are set by pressing the [Select] key until the desired output level LED is set. The vernier setting is programmed using the CAL menu. Press [Calibrate] until the left display shows 'vtESt'. The right display will show the present output voltage. Although the unit will accept 3 digits, it will round the entered voltage to the nearest 50 mV. When the output voltage has been programmed with the vernier setting, none of the primary drive voltage LEDs will be on. To return to the primary output levels, press the [Select] key. The output voltage will be increased to the next highest primary level.

The output voltage is applied to the device under test through a source impedance, thus, the voltage across the device is always less than or equal to the output voltage. The different source impedances are 25 Ω (R3), 400 Ω (R2), 6.4 kΩ (R1), and 100 kΩ (R0), all accurate to 2 %. The source impedance is selected as a function of the measurement range, unless the unit is in constant voltage mode. In the constant voltage mode, the source impedance is always 25 Ω. See the next section for determining which measurement range the unit is using.

The graph above shows the voltage across the Device Under Test (DUT) vs the

Voltage Across DUT vs DUT Impedance
For Different Ranges
Normalized to 1.0 Volt
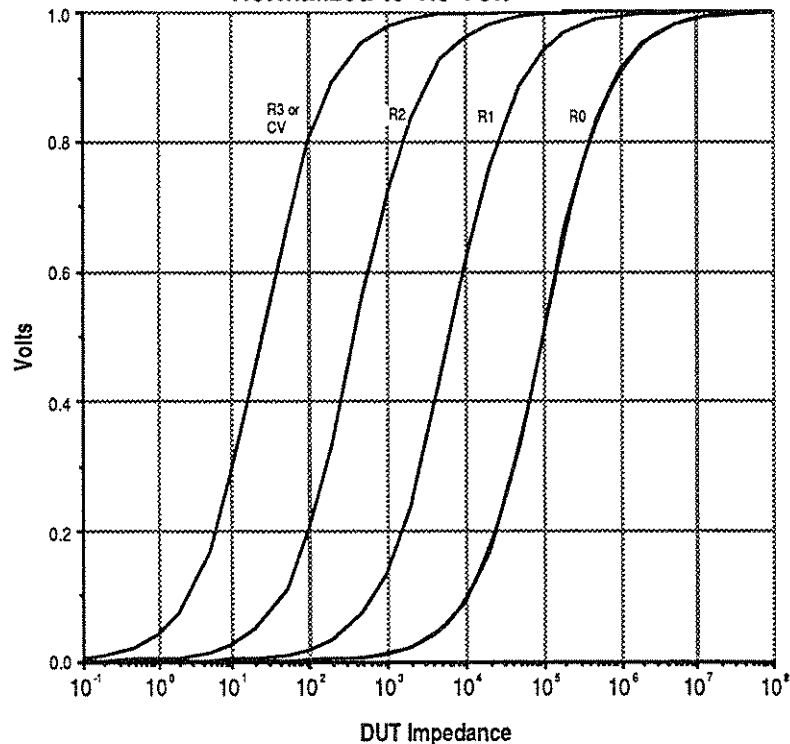
DUT impedance for the different measurement ranges. The values are normalized to a 1.0 V output drive setting; for different applied voltages simply scale the graph values by the applied voltage. Note that the voltage applied to the DUT is nearly equal to the output voltage at the upper end of each range and decreases with lower impedance toward the lower end of the range. This is because of the output source impedance. If the unit is in constant voltage (CV) mode, the source impedance is always set to 25 Ω. For any impedance significantly larger than

25 Ω, the voltage across the part is essentially equal to the output drive voltage.

For most devices, including resistors, most capacitors and many inductors, the 1.0 Vrms setting is the most appropriate setting. For some inductors and active devices, such as diodes and transistors, the 0.25 or 0.10 Vrms setting should be used. Certain devices require a specific test voltage, such as Z5U ceramic disk capacitors (test voltage = 0.5 Vrms). In these cases, use the vernier setting to obtain the exact voltage required. In general use the largest voltage possible for the best signal to noise ratio and accuracy.

RANGE The SR715/720 has 4 measurement ranges (0-3). The range may be selected manually or the unit can autorange. The table below specifies the impedance ranges for each of the measurement ranges. Each of the four ranges has a source impedance of approximately the mid-scale impedance. Note that the measurement ranges determine an impedance range (not a value range), so the ranges of inductance and capacitance depend upon the test frequency. The parameter f is the test frequency. In addition, the impedance of capacitors is inversely proportional to its capacitance, so larger capacitors are measured in the lower impedance ranges.

Measurement Range and Impedance Range

Meas Range	Source R	Resistance	Inductance	Capacitance
3	25.0 Ω	10 μΩ - 100.0 Ω	0.0001 μH - 15.9/f H	99999 μF - 1.59/f mF
2	400 Ω	100.0 Ω - 1.6 kΩ	15.9/f H - 256/f H	1.59/f mF - 99.5/f μF
1	6.4 KΩ	1.6 kΩ - 25.6 kΩ	255/f H - 4074/f H	99.5/f μF - 6.22/f μF
0	100 KΩ	25.6 kΩ - 2000 MΩ	4074/f H - 99999H	6.22/f μF - .00001 pF

f is test frequency

AUTORANGING During normal operations the unit automatically changes to the most accurate range for the device under test. When the unit measures an impedance that is out of its current range, it goes up or down one range, and makes another measurement. If this measurement is within the current range it displays it; If not, it changes ranges (if available), and repeats this process. There is built in hysteresis to avoid repeated range changes when a component is on a range boundary. Up range changes occur when the impedance measured exceeds 450% of the midscale impedance (i.e. the source impedance), or 12.5% over the nominal range limit. Down range changes occur when the measured impedance drops below 22% of the midscale impedance, or 12.5% below the nominal range. See the table below for the actual values where the range changes occur.

Range Change Points When Autoranging

Ranging To Lower Impedances		Ranging To Higher Impedances	
Range Change	Impedance	Range Change	Impedance
2 to 3	Z < 88 Ω	3 to 2	Z > 115 Ω
1 to 2	Z < 1.4 kΩ	2 to 1	Z > 1.8 kΩ
0 to 1	Z < 22.4 kΩ	1 to 0	Z > 29.9 kΩ

RANGE HOLD

It is sometimes desirable to disable autoranging since it takes nearly a complete measurement cycle each time a range changes occurs. This can be annoying if there are no parts in the fixture and the unit is continuously triggering, since an empty fixture appears as a very large (nearly infinite) impedance. The unit will autorange to range 0 (or range 1 for 100 kHz) and then autorange back to the appropriate range when a part is inserted in the fixture. Range holding is helpful if measurement speed is a concern or if a number of parts with similar values are being measured.

There are two ways to range hold. The present measurement range can be held by simply pressing the [Range Hold] key. The LED above the [Range Hold] key indicates that the unit is in range hold. A measurement range can also be directly entered from the ENTRY display. Select the ENTRY display using the [Display] key, then press [Range Hold]. The message 'rAngE' will appear in the left display, and the present range, 0-3, will appear in the right display. Enter the desired range and press the [ENTER] key. Use the [Display] key to return to the desired display. The range hold LED will be on. If an invalid range is entered, the unit will beep and display the message 'rAngE ErrOr' and not accept the range entry. Range 0 cannot be entered when the frequency is set to 100 kHz (SR720 only). If this is attempted the unit will beep and display an 'r-f Error' (range - frequency error).

To return the unit to autoranging mode, simply press the [Range Hold] key.

If the impedance of a part is more than 100 times the nominal value for the range, the instrument indicates an 'ovEr rAnGE' (overrange) error. If this occurs, choose a more appropriate range for the measurement. Measurement accuracy is reduced if a component is measured outside of its optimal range. The accuracy of an out-of-range measurement is as follows: for each factor of 2 outside of the nominal range, the total error increases by the basic error. For example, if a part is 4 times greater than the nominal range (2 factors of 2), then the total error will be the basic accuracy + 2 x the basic accuracy. In this case, the total error increases to 3 x the basic error. For more information, see the accuracy section.

CONSTANT VOLTAGE

Occasionally, a test will require using a specific drive voltage that is not possible using the normal source resistance for that measurement range. In these cases, use the [Cons Volt] key to set the source impedance to a fixed 25 Ω. The voltage across the DUT will be almost constant for all devices with impedances substantially larger than 25 Ω. When the unit is in constant voltage mode, the measurement ranges change to avoid overloading the unit. However, it also reduces the accuracy of the measurement by a factor of 2. See the accuracy section for more detail. The table below lists the impedance ranges when using Constant Voltage.

Measurement Range and Impedance Range for Constant Voltage Mode

Meas Range	Source R	Resistance	Inductance	Capacitance
3	25.0 Ω	10 μΩ - 360 Ω	0.0001 μH - 57/f H	99999 μF - 442/f μF
2	25.0 Ω	360 Ω - 5.76 kΩ	57/f H - 917/f H	442/f μF - 27.6/f μF
1	25.0 Ω	5.76 kΩ - 90.0 kΩ	917/f H - 14324/f H	27.6/f μF - 1.77/f μF
0	25.0 Ω	90.0 kΩ - 2000 MΩ	14324/f H - 99999 H	1.77/f μF - .00001 pF

f is test frequency

Range Change Points When Autoranging in Constant Voltage Mode

Ranging To Lower Impedances		Ranging To Higher Impedances	
Range Change	Impedance	Range Change	Impedance
2 to 3	Z < 315 Ω	3 to 2	Z > 400 Ω
1 to 2	Z < 5.04 kΩ	2 to 1	Z > 6.4 kΩ
0 to 1	Z < 78.8 kΩ	1 to 0	Z > 100 kΩ

Under certain conditions the 'ovEr LoAd' message will be displayed. This normally occurs when the unit is in constant voltage with the range hold on. To correct this, simply change to a higher impedance range, or autorange.

BIAS   Internal or external DC bias voltages can be applied to capacitors. Electrolytic and tantalum capacitors need a positive bias for accurate measurements, although the SR715/720 bipolar test voltage will not typically be enough to damage them. The 2 VDC internal or up to 40 VDC external bias voltage allows measurements to be made while approximating actual operating conditions. The external bias capability also allows C-V measurements to be made on semiconductor devices.

Always make certain that the capacitor being tested is inserted with the correct polarity. **The bias voltage is always positive to the right** and is marked on the SR715/720. **Failing to observe the correct polarity can result in the destruction of the DUT and possible injury.** Be aware that charged capacitors can hold their charge for a long time if removed from the fixture without discharging the DC bias voltage. Care must be taken to discharge the capacitors after making measurements, **ESPECIALLY WHEN USING EXTERNAL BIAS WITH LARGE VOLTAGES !!** Failing to discharge the device can result in damage to the device, damage to the SR715/720, or possible injury !! The SR715/720 is protected internally against discharging capacitors with up to 1 Joule of stored energy ($C \cdot V^2 / 2$).

The internal and external bias circuitry will work only if the unit is in the C+D or C+R mode. Bias cannot be applied if the unit is in the R+Q, L+Q or the AUTO mode. The error message of "biAS for c" will appear if the bias key is pressed in the inappropriate mode. Whenever the bias circuitry is active the unit is in the constant voltage mode so that the voltage across the capacitor under test will stabilize in a reasonable amount of time. See the constant voltage section for effects on ranges and accuracy.

It will take a short while for the internal circuitry and the DUT to stabilize after applying the bias voltage. The time is primarily determined by the RC time constant of the source resistance and the capacitor under test plus the internal AC coupling capacitor of .47 μF. During this time the reading on the SR715/720 may change if it is continuously triggered. In this case, the initial readings should be disregarded. If this is a problem, use the triggered mode (simply wait a short time before triggering) or increase the settling time. See the section on measurement rate for information on how to set the settling time. In addition, the capacitance of some capacitors will slowly drift after a change in DC voltage.

INTERNAL BIAS

To apply the 2.0 VDC internal bias voltage, first verify that the capacitor is installed with the correct polarity in the test fixture (positive to the right). Press the [Internal] bias key to apply the bias voltage. After a second or two the reading should be stable. Press the [Internal] bias key a second time to switch off the bias to discharge the capacitor before removing it from the fixture.

EXTERNAL BIAS

The SR715/720 has rear panel connections to allow an external bias voltage of up to +40VDC to be applied across the DUT. This supply must be floating (neither side connected to ground) and must be current limited to less than 250 mA. A linear supply is recommended (vs. switching supply). The supply should be well filtered, to remove ripple from the bias voltage. Connections to the bias supply are made on the rear panel with two banana jacks. The red jack is the positive side of the supply and the black, the negative. There is an internal diode within the unit to prevent a negative voltage from being applied. The bias supply lines are fused with a 250 mA fuse on the rear panel, next to the banana jacks. If the SR715/720 doesn't yield stable readings when the external bias switched is on, check this fuse. If the bias supply is connected backwards, there is a good chance that the bias supply fuse will blow. Provisions need to be made to discharge the bias voltage from the capacitor under test before removing it from the fixture. In general, external switches or discharging resistors need to be provided with the bias supply to ensure safe operation.

To apply an external bias voltage, ensure that the bias supply is connected correctly. Then verify that the capacitor is installed with the correct polarity in the test fixture (positive to the right). Next press the [External] bias key to apply the bias voltage. After a second or two, the reading should be stable. After the measurement is complete, discharge the DUT before removing it from the fixture.

For occasional use (non production) with small capacitors (<500 μF) and low bias voltages (<20 VDC), the SR715/720 can discharge the capacitor internally. Press the [External] bias key to switch off the bias. The capacitor will then discharge through the unit in the same manner as the internal bias. Another solution for somewhat larger bias voltages and/or capacitors is to connect a resistor across the terminals of the bias supply. Switch off the bias supply and allow the capacitor to discharge through the resistor before removing it from the fixture. Make cer-

tain the discharge resistor is rated to handle the steady state current that the bias voltage will generate through it and that the supply can provide this additional current. For larger capacitors or higher supply voltages it will be necessary to provide external switches to remove the bias voltage and discharge the capacitor.

MEASUREMENT RATE   The SR715/720 has three measurement rates: slow, medium and fast. These correspond to about 2, 10 and 20 measurements per second on the 1 kHz,10kHz and 100 kHz (SR720 only) frequencies and about 1/10 of that for 100 Hz and 120 Hz frequencies. The table below lists the maximum measurement rates for the different test frequencies. These rates are attainable when the unit is not in auto-range mode, binning is disabled, and neither GPIB nor RS232 interfaces are active. The measurement rate affects the accuracy, with slow and medium being the most accurate and fast being the least accurate.

Measurement Rate
Number of measurements/sec

Frequency	Slow	Medium	Fast
100 kHz	2.8	14	28
10 kHz	2.8	14	27
1 kHz	2.7	13	24
120 Hz	0.7	2.8	7
100 Hz	0.6	2.4	6

The actual measurement time can be calculated from the following equation.

$$T_{meas} = T_s + [(N_i \cdot 1/f + T_{di} + T_{rs} + T_d) \cdot N_m] + T_{calc}$$

where T_s = settling time, N_i = number of test frequency cycles used in the measurement, f = test frequency, T_{di} = deintegration time, T_{rs} = resync time, T_d = delay time, N_m = number of submeasurements per measurement, and T_{calc} = calculation time. T_{di}, T_d, and T_{calc} are constants, T_{rs} and f are set by the measurement frequency. N_i and N_m are determined by the measurement rate and T_s can be set by the user. See the table below for the appropriate values.

N_m	Slow	8
	Medium	8
	Fast	5

		100,120 Hz	1 kHz	10 kHz	100 kHz
N_i	Slow	20	40	400	4000
	Medium	4	4	40	400
	Fast	2	2	20	200

T_{rs}	1/f
T_{di}	2 ms
T_d	2 ms
T_{calc}	3 ms
T_s	2-99 ms

In addition to these factors, the measurement time is increased when using auto-ranging, binning or the GPIB or RS232 interfaces. Binning adds about 2.5 mS to

the total measurement time. Autoranging adds $n \cdot (T_{meas} - 1mS)$ where n=number of range changes required and T_{meas} is calculated above.

It is difficult to determine the exact amount of time added when using GPIB or RS232 interfaces, since it is dependent on baud rate, the speed of the computer and the software. It takes about 5 mS for the unit to respond to a command after it is received and about 5 mS to format a response to send back over the interface. In general, simple commands and responses, like setting the frequency or checking what range the unit is on, can be returned in about 10 mS. Longer responses, like XALL?, can take as long as 2 seconds over RS232. If communications speed is critical, the binary data format, which reduces the number of bytes transferred, can be used.

SETTLING TIME   Occasionally it is advantageous to delay making a measurement after the unit is triggered. This allows bias voltages on capacitors to stabilize or contacts on a handler to debounce. The settling time is set in 1 ms intervals from 2 to 99 ms. To set the settling time, press the [Calibrate] key until the 'SEttL' message appears in the left display and the present settling time value in the right display. Enter the new settling time value, from 2 to 99, and press the [ENTER] key. If an illegal value is entered the unit will beep and display 'rAngE Error'.

TRIGGERING   The SR715/720 can make measurements continuously or in response to a trigger. To change the trigger mode, press the [Mode] key until the desired mode LED is on, either CONT or TRIGGERED. In the continuous mode the unit will trigger itself at its maximum measurement rate. In triggered mode, the trigger can be from the [Trigger] key, from the RS232 or GPIB interfaces, or from the Handler interface. While making a measurement, the unit will ignore any triggers it receives until the current measurement is complete. The TRIG LED will flash whenever the unit is triggered. In the triggered mode the unit will make a single measurement per trigger.

STORE and RECALL

[Store] and [Recall] allow nine complete instrument setups to be saved in non-volatile memory. All the test conditions, including binning configuration and open and short circuit compensation are saved.

Store   To store a setup, press the [Store] key, which will display the 'StorE' message in the display. Press the number of the stored setting ([1] - [9]) and the [ENTER] key. [Store] [0] [ENTER] will give an error since setup 0 is the factory default setup.

Recall   To recall a stored setting, press the [Recall] key, which will display 'rcL'. Press the number of the stored setting ([1] - [9]) and the [ENTER] key. [Recall] 0 returns the default setup, including null cal values. If a 'CAL Err 4' appears during self test, or a 'rcL Err' appears when recalling a setup, the stored setup was lost and must be re-entered.

CONNECTING A DEVICE

The SR715/720 has a built in Kelvin fixture for measuring radial leaded components and adapters for measuring axial leaded components. The fixture provides a 4-wire Kelvin connection to the device under test to minimize stray impedances that cause measurement errors. Most components will fit into this fixture, thus eliminating the need for special fixtures. **Remember, whenever the fixture configuration is changed, open and short circuit calibrations should be performed before making measurements.** Open and short circuit calibration values are stored in non-volatile memory with the [Store] and [Recall] keys along with the complete instrument setup. This allows compensation values for different fixtures to be stored then recalled whenever different measurement setups are required. Also remember that when measurements are in progress, keep hands or any other objects away from the fixture because the measurement accuracy may be affected. There is a cover beneath the fixture to catch any leads that might fall through the fixture. For information on removing leads or general maintenance to the fixture in general, refer to the Maintenance section.

RADIAL LEADED PARTS   To measure parts with radial leads, (leads coming out the same side of the package) first remove any adapters or parts from the fixture, since they will interfere with making a Kelvin connection. Next, make sure the leads are reasonably clean of wax or other coatings. These can cause an unreliable contact and gradually build up in the fixture. Insert one lead into each side of the fixture, approximately centered and make the measurement.

AXIAL LEADED PARTS   To measure parts with axial leads, (leads coming out opposite ends of the package) first remove any parts from the fixture. Install the axial adapters in the center of each fixture half and slide them apart or together so the DUT will be approximately centered in the fixture. Check that the leads are reasonably clean and insert one lead in each side of the fixture adapter. After removing the axial lead adapters, replace them in the two storage slots behind the fixture so as not to misplace them.
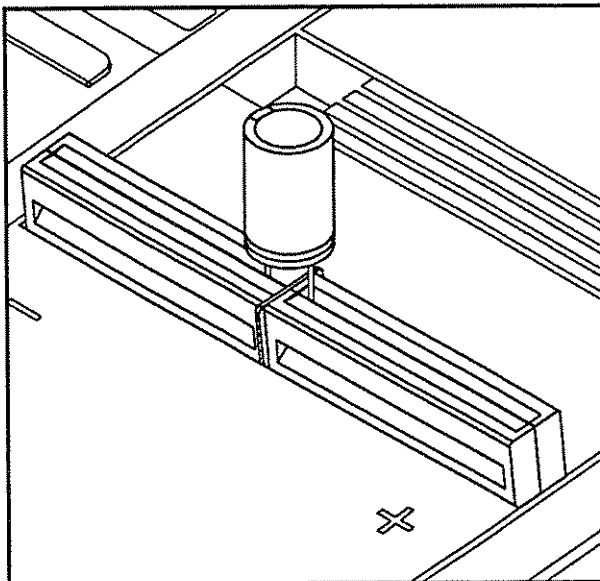
Radial Fixture (with part)
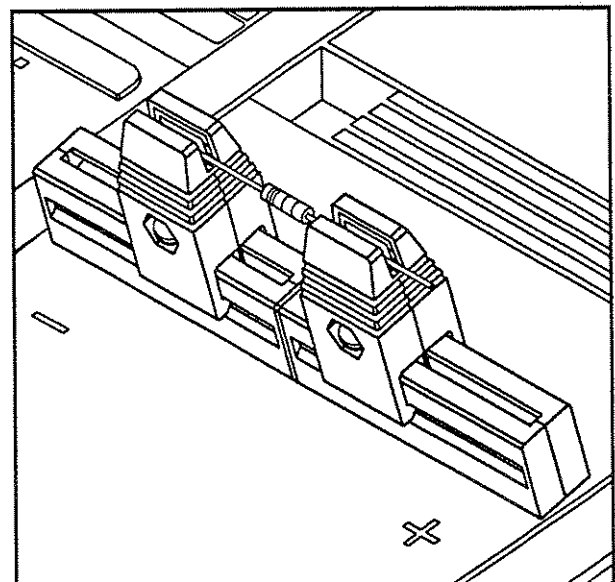
Axial Fixture (with part)

COMPONENT DIMENSIONS The radial fixture can accommodate components with a lead spacing from 0.2" (5mm) up to 3.8" (96.5mm) with a minimum lead length of 0.16" (4mm). The axial lead adapter can accommodate parts with a maximum body length of 2.7" (68.6mm) and a maximum diameter of 1.8" (45.7mm). The closest the adapters can get is 0.12" (3.0mm). The minimum lead length (of each lead) is 0.25" (6.4mm). However the minimum length of the part and lead combined is 0.7" (17.8mm). See the diagrams below. Lead diameter for either fixture configuration can vary from 0.008" (.20mm or 32 AWG) up to 0.070" (1.8mm or 13 AWG).

Radial
Component

Axial
Component

Max. Diameter
1.8" (45.7 mm)

Max Width 2.7" (68.6 mm)

Lead Spacing
0.2" - 3.8"
(5 mm - 96.5 mm)

Min. Width
0.7" (17.8 mm)
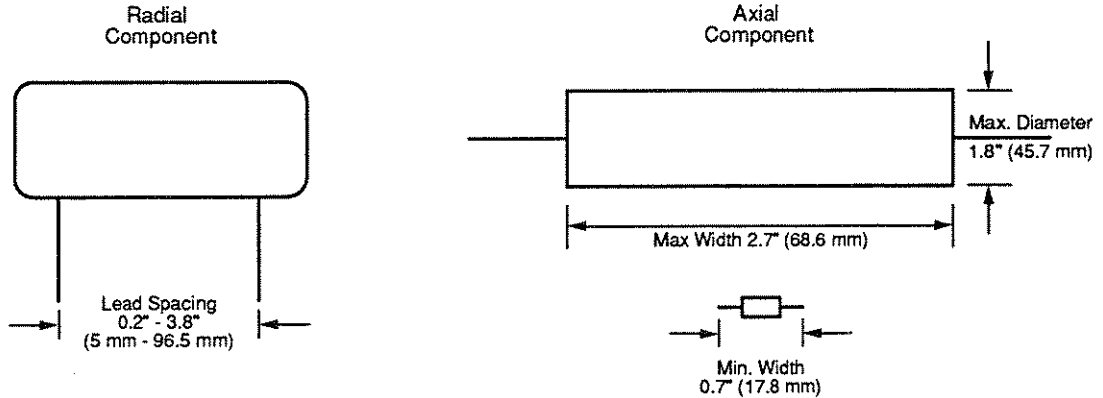
OPTIONAL FIXTURES

ADAPTER The Kelvin Clips, SMD Tweezers and BNC adapters all connect to the SR715/720 fixture using the same adapter. To install the fixture adapter, first remove any parts or adapters from the fixture. Then plug the fixture adapter into the fixture, matching the polarity of the adapter to the polarity of the SR715/720. Make certain that the center clips makes contact with the center guard ground.
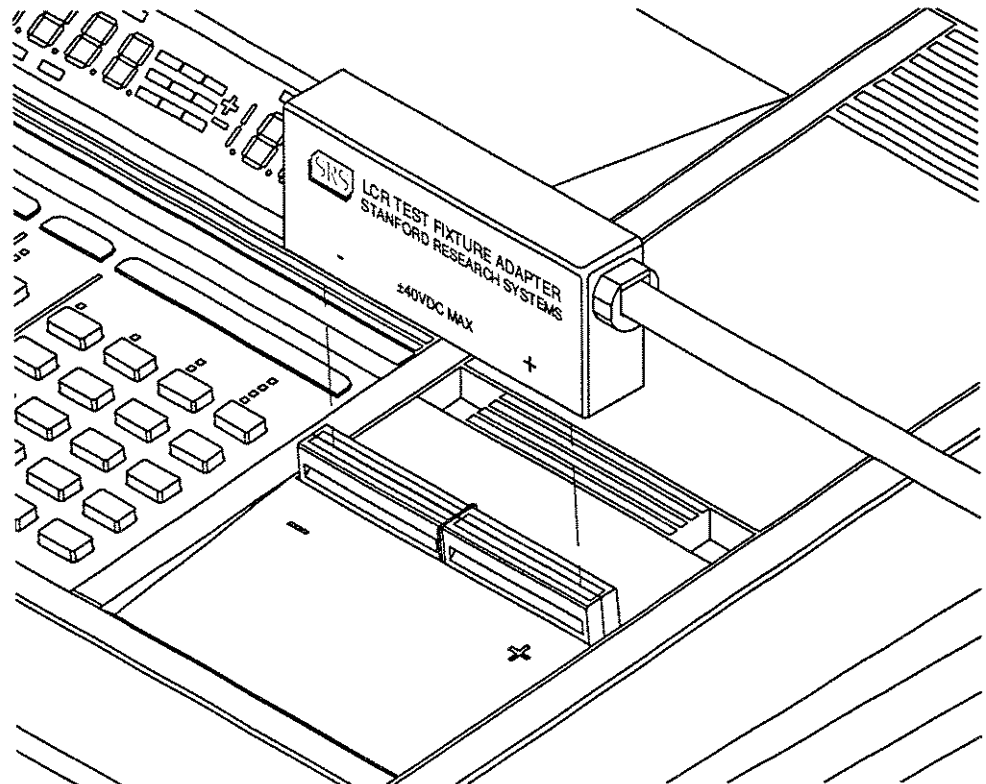
KELVIN CLIPS   Kelvin Clips provide a simple means to measure large or unusually sized parts. They can connect to any component lead up to 0.3" (7.6mm) in diameter. When connecting the Kelvin Clips to a device, remember that the red lead denotes the "+" side of the fixture if any biased measurements are made. Connect one clip to each side of the component and perform the measurement. Whenever the fixture configuration is changed, be sure to perform open and short circuit calibration. Kelvin Clips will give the best results if they are used at frequencies of 1 kHz and below and impedances of 1 MΩ or less. At higher frequencies, lead position and other subtle conditions can change stray impedances, affecting measurement accuracy. For measurements outside of these limits, a test fixture is advised.
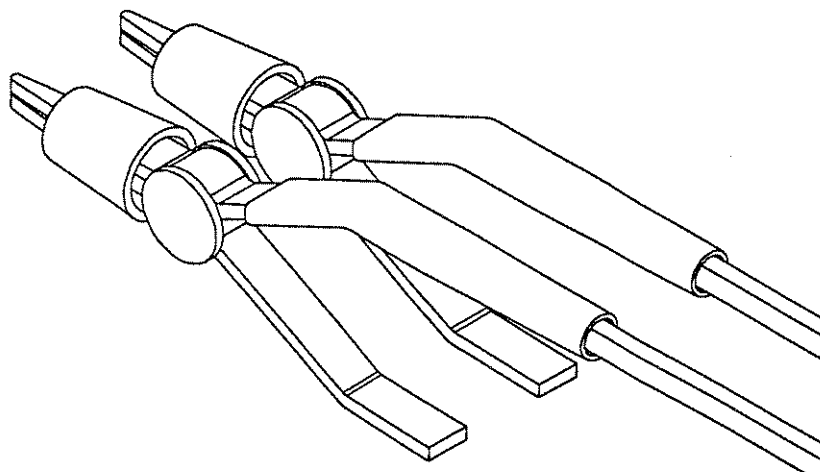
SMD TWEEZERS   The SMD Tweezers provide a combination of test fixture and handling tweezers for measuring surface mount devices. The tweezers make a Kelvin connection to devices up to 0.4" (10.2mm) wide and make it easier to measure and sort these small components. The parts tray in front of the fixture provides a convenient place to place parts while sorting and measuring them. Connection of the SMD tweezers to the SR715/720 fixture is the same as for the Kelvin Clips. Remember, always perform open and short circuit calibration after changing the fixture setup. The tweezers are marked with the same polarity as the fixture for making biased capacitance measurements. (Some units do not have the polarity marked. The side with the silkscreen is the positive side.) To make a measurement, pick up the component with the SMD tweezers so that the metallized ends of the parts contact the tips of the tweezers. The tips can be replaced if they wear out or break. See the maintenance section for details on changing them.

3-15
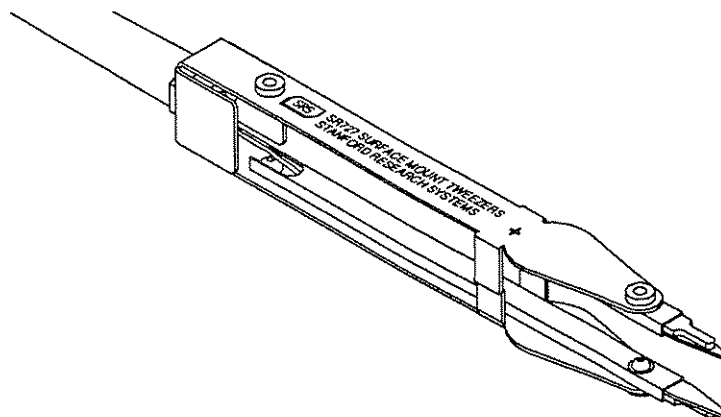
BNC ADAPTER   The BNC Adapter Set connects the SR715/720 to other test equipment, switching networks, or remote test fixtures. The adapter connects to the test fixture in the same fashion as the Kelvin Clips and SMD Tweezers. The four coax cables are labeled: I_h (red), the + drive signal, I_l (blue), the - drive signal, V_h (orange), the + sense connection, and V_l (purple), the - sense connection. When connecting these cables to a device, connect the two + signals to one side of the device and the two - signals to the other side. The + leads have the same polarity as the fixture when using DC bias signals. The shields of the four cables should not connect to each other. The shields of the two drive connections (I_h and I_l) should be connected to each other and to a shield, case or guard at the fixture or DUT, if possible. The shields of the sense signals (V_h and V_l) should float. If extension cables are used, it is important that the connector shields do not make contact with each other.
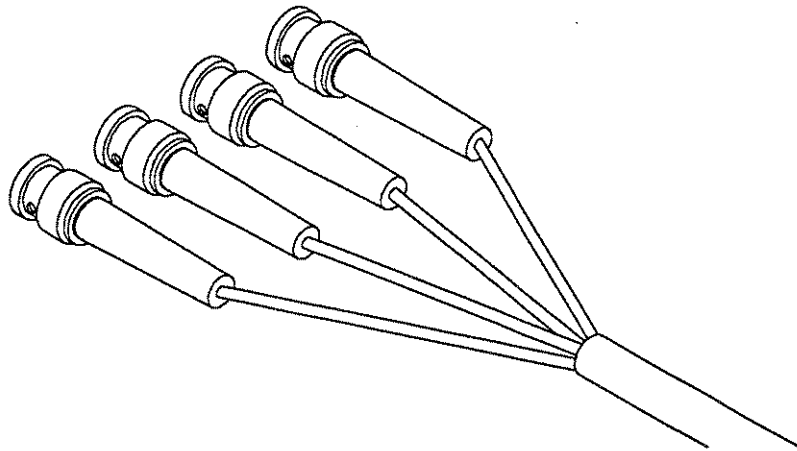
OPEN and SHORT CIRCUIT OR NULL CALIBRATION

Compensation of stray impedances is performed by open and short circuit or fixture null calibration. This corrects for lead impedance, and fixture, cable and other stray capacitance. Null calibration corrects for all frequencies and all ranges - it is not necessary to re-calibrate for changes in frequency. Null calibration should be performed after any change in fixture configuration or for changes in the drive amplitude. For critical measurements, null cal should be performed frequently, possibly several times a day. The open and short circuit values are stored with the [Store] and [Recall] keys, allowing null calibration data to be saved for different fixture configurations.

The Null Calibration procedure is in the CAL menu. Press the [Calibrate] key until the message 'nuLL cAL' appears on the display. Press the [ENTER] key and the message will change to 'Short cAL'. Place a wire of between 26 to 16 AWG (0.02" to 0.05" or 0.51 to 1.30 mm dia.) in the fixture. Press the [ENTER] key and move hands and any miscellaneous objects away from the fixture. When the short circuit cal is finished, the 'oPEn cAL' message will be displayed. Remove the shorting wire, press [ENTER] and again move your hands away from the fixture. When the unit has finished, the message 'cAL donE' will be displayed. Use the [Display] key return to the desired display.

Suggestions for Calibration

It is always best to perform the null calibration in the same configuration that measurements will be made. This will ensure that stray impedances will be cancelled out as completely as possible. Also, keep any objects away from the fixture that will not be present during measurements, for example hands or pieces of metal. (To observe the effect your hand has on impedances, place a small capacitor, ~10pF, in the fixture and observe the change in measured capacitance as you move your hand closer to the fixture. This is due to your hand disturbing the electric fields around the fixture). For high impedance measurements, the open circuit null will be more accurate if the fixture contacts are clean. A piece of paper (the coarser the better) slid back and forth between the contacts will clean them (if they are not too dirty).

RADIAL FIXTURE Use a "U" shaped piece of copper wire, 26 to 16 AWG (0.02 to 0.05" or 0.51 to 1.30 mm dia.), 2"-3" long (50-80mm) for the shorting wire. Insert the shorting wire in both sides of the fixture at about the same places that the component leads will be inserted.

AXIAL FIXTURE ADAPTER Place the axial adapters in the desired locations on the fixture. For the shorting wire, use a straight piece of wire or a lead (26-16 AWG) that fits in the contacts in the same fashion as the parts to be measured do.

KELVIN CLIPS It is more difficult to get an accurate null calibration with the Kelvin clips than with a fixture, since their physical configuration is less controlled. As always, place them as close to the measurement configuration as possible while making null measurements. For the shorting measurement DO NOT connect the two clips together. Connect the two clips to the same side of a DUT, ensuring the same contact resistance that as in actual measurements. For the open measurements, leave one clip attached to the DUT and position the other at about the same separation as it will be when making measurements. Again keep hands or other objects away from the clips while performing null cal. See the illustration below.
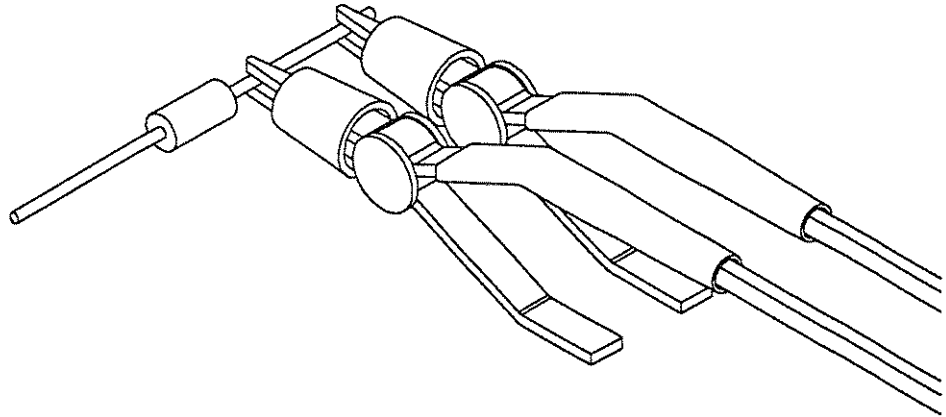
SMD TWEEZERS   SMD tweezers present a challenge to calibrate accurately, since their position can vary and the operators hands are always present when making measurements. Use a piece of copper (shorting block) about the same dimensions as the devices to be measured, as the shorting wire. DO NOT just touch the tips together. A shorting block can be made from an SMD device by connecting the two ends with copper tape or solder to create a short circuit. When performing open circuit cal, hold the tips about the same distance apart as they will be when measuring parts and keep your hands still. Sometimes it is valuable to check the "quality" of the null calibration by measuring the part that was used to perform the null cal (the shorting block). If the residual error is larger than the measurement can tolerate, it may be necessary to re-do it until an acceptable calibration is achieved.
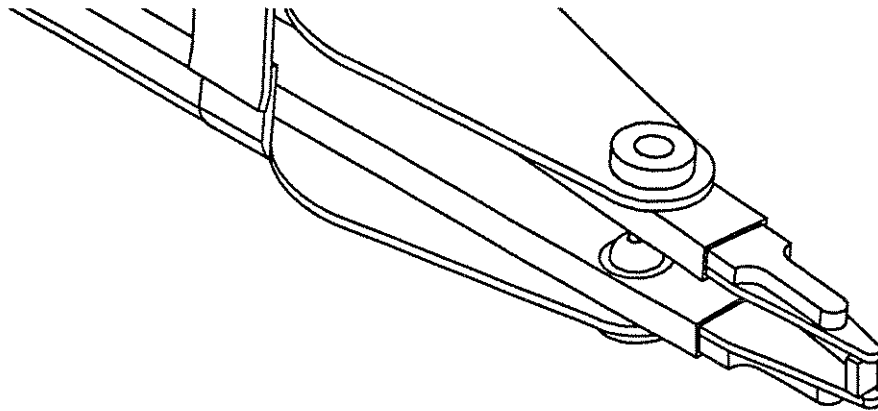
Other Fixtures   In general, follow the procedure for performing null cal as described above. Use a configuration similar to one that will be used when making measurements and keep any random objects far away.

BINNING

The SR715/720 has built in features to aid in component sorting. This is especially useful for production testing, incoming inspection, device matching or tests where multiple devices of similar value must be measured. The binning feature simplifies parts sorting by eliminating the need to read the major and minor parameters and then deciding what to do with the part. [Store] and [Recall] allow up to 9 binning configurations to be entered and saved making it easy to change between different setups. Binning configurations can also be entered over one of the computer interfaces. The SR715/720 can sort components into as many as ten separate bins - eight pass bins, a minor parameter failure bin, and a general failure bin. Binning operations can either be performed from the front panel, in the BINS display, the standard RS232 computer interface or the optional GPIB or Handler interface.

There are three different types of binning schemes that the SR715/720 supports: Pass/Fail, Overlapping, and Sequential. Pass/Fail has only two bins; good parts and everything else. Overlapping or nested bins have one nominal value and are sorted in progressively larger bins (+/-1%, +/-2%, +/-3%). Sequential bins can have different nominal values, each separated by a percentage (.9*nom, .95*nom, 1.0*nom, 1.05*nom, with 5% limits) or a single nominal value and asymmetrical limits (-3% to -1%, -1% to 1%, 1% to 3%). Limits are pairs and can be symmetrical (+/-2%) or asymmetrical (-5% to -1%). Examples of different binning schemes are listed below.

Nested Bins 100 Ω resistors sorted into progressively looser symmetric limits pairs with a single nominal value.

Nominal value = 100 Ω
Bin0: +/-1%
Bin1: +/-2%
Bin2: +/-3%
Bin3: +/-4%
Bin8: QDR failure bin (if Q was too high)
Bin9: General Failure bin (parts that don't fall into any other bin)

Nested Binning

Nominal Value

-4% -3% -2% -1% 0 +1% +2% +3% +4%
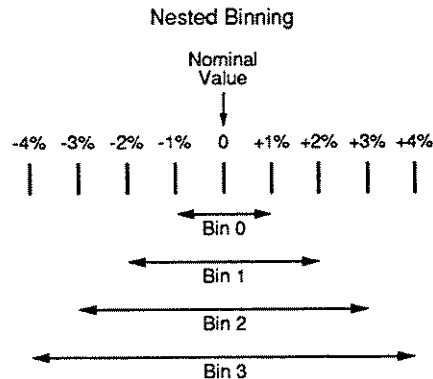
Bin 0

Bin 1

Bin 2

Bin 3

1. Sequential Bins 100 Ω resistors sorted into symmetric 1% limit pairs, each with a different nominal value.

Bin0: nom : 98.2 Ω +/-1%
Bin1: nom : 100 Ω +/-1%
Bin2: nom : 102 Ω +/-1%
Bin3: nom : 104 Ω +/-1%
Bin8: QDR failure bin (if Q was too high)
Bin9: General Failure bin

Sequential Binning

1. | Bin 0 | Bin 1 | Bin 2 | Bin 3 | Bin 4 | ... | ... | ... |
98Ω 100Ω 102Ω 104Ω 106Ω
+/-1% +/-1% +/-1% +/-1% +/-1%
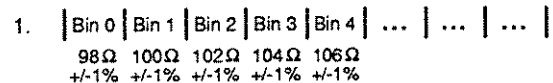
2. Sequential Bins 100 Ω resistors sorted with asymetric limit pairs and a single nominal value.

Nominal value = 100 Ω
Bin0: -5% to -3%
Bin1: -3% to -1%
Bin2: -1% to +1%
Bin3: +1% to +3%
Bin8: QDR failure bin (if Q was too high)
Bin9: General Failure bin

Nominal Value

2. | Bin 0 | Bin 1 | Bin 2 | Bin 3 | Bin 4 | ... | ... | ... |
-5% -3% -1% +1% +3% +5%
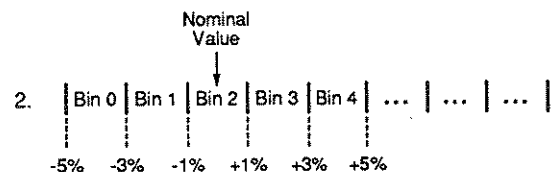
Binning data can be entered manually using the [Bin#], [Nominal] and [Limit] keys, or over the RS232 or optional GPIB interface. A bin is defined by a bin number, with a nominal value and upper and lower limits (in percent). If a nominal value is not entered for a bin, it will take the nominal value of the next lower bin. Bin 0 is the exception. If bin 0 doesn't have a nominal value and limits, all parts will fail. Parts that fall into more than one bin are assigned to the lower numbered bin. Thus, the tightest tolerances should be assigned to the lowest bin number. Any parts that fall into gaps between bins are assigned to the general failure bin (bin 9). If only one limit of a pair is entered, the limits will be assumed to be a symmetric pair (+/- x %, where 'x' is the entered limit value). Unused bins should be closed (assigned 0% limits). After bin clear or [Recall] [0], all bins are closed. Parts that fall into both the general fail bin (bin 9) and the QDR fail bin (bin 8) are assigned to the QDR fail bin. The QDR limits are maximums or minimums depending on which parameter is being measured. If a Q value is negative, (for resistors) the absolute value should be entered, and the meter performs a comparison between the absolute value of the QDR reading and the QDR limit. There are no limits for the QDR bin, only a nominal value. To disable the QDR comparison, set the nominal value to its extreme value.

Parameter being measured	QDR Limit	Extreme Value (disabled)
R+Q	Q maximum	9999.9
L+Q	Q minimum	0
C+D	D maximum	9999.9
C+R series	R maximum	99999
C+R parallel	R minimum	0

SETTING UP THE BINS

INITIAL   To enter binning information the unit can not be in the AUTO parameter mode. Make certain that the unit is set to the correct parameter (R+Q, L+Q, C+D or C+R). Press the [Bin#] key which will bring up the bin entry display and put the unit in the entry mode. If any previous binning information needs to be cleared, press the [Bin#] key until the 'bin cLEAr' message appears. Press the [ENTER] key to clear all bin data and display 'cLEAr donE'. To enter new bin data or to edit old bin data (if it wasn't previously cleared), press the [Bin#] key until the unit displays 'bin x'. Enter the desired bin number ([0] thru [8] then [ENTER]). The bin number will appear on the right display. This is the bin for which subsequent nominal and limit values will be entered.

NOMINAL VALUES
FOR PASS BINS (0-7)   To enter the nominal value, press the [Nominal] key. The display will show the present nominal value, or '-----' if the bin was previously closed in the left display. The 'NOM' LED below the display will be on. If a nominal value is needed for this bin, enter the desired nominal value with the numeric keys and the unit entry keys. The new nominal value, including units will be displayed. Note that a nominal value doesn't have to be entered for each bin. If a bin doesn't have a nominal value it will use the one from the bin below it.

LIMITS FOR
PASS BINS (0-7)   To enter the limits, press the [Limit] key. The display will show the present upper limit value, or '---' if no limit existed previously. The +LIM LED below the display will be on. Enter the limit value in percent using the numeric keys and the [ENTER] key. If it is necessary to enter a non-symmetrical limit pair, press the [Limit] key a second time to display the present lower limit value. The -LIM LED will turn on. Enter the lower limit in the same fashion as the upper one. For symmetric limits, enter only the upper value; the lower limit will be the negative of the

upper limit. If no limits are entered for a bin, that bin will remain closed, even if it has a nominal value.

**VALUES FOR
FAIL BINS (8 & 9)**   To set the QDR limit value, select bin 8 (using the [Bin#] [8] [ENTER] keys) and press the [Nominal] key. This will display the present QDR limit, or '-----', in the right display and turn on the NOM LED. Input the value with the numeric keys and press the [ENTER] key. Resistors for the C+R mode are entered in Ω (the allowable range of resistance values is only 0 to 99999 Ω, so no kΩ or MΩ key is needed). There are no limits for the QDR bin. Bin 9, the general failure bin, cannot be set. Parts that do not fall into any other bin are assigned to this bin.

ENABLE BINNING   To enable or disable binning, press the [Bin#] key until the 'Sort oFF' or 'Sort on' message appears. Pressing the [ENTER] key from this display toggles binning (sorting) on and off. When binning is enabled, the BINNING LED is on, the BINS display is active, and the handler interface (if installed) is active. The handler interface is active whenever binning is enabled, whether or not the BINS display is on. See that section for more information on the Handler interface.

Before entering binning information, it is usually better to write down the desired binning setup since it is a fairly complicated procedure. See the binning worksheet on the next page. Also, be sure to save setups that are used often. Certain setups can be edited, for example, one percent resistors using the same nominal value. A different value of resistor could be sorted by simply changing the nominal value, if the only nominal value entered was for bin 0. For this reason, it is often better to enter sequential binning data with a single nominal value and different percentage limits, instead of with different nominal values (overlapping limits are always entered in that fashion, so it isn't an issue for them). It is advisable to check the nominal values and limits before making measurements, to be certain that they haven't been modified. The binning setup can be viewed in the same manner as it was entered; just don't press the [ENTER] key unless a value needs to be changed.

Examples

PASS/FAIL   Enter the nominal value and limits for bin 0. Enter the QDR fail value for bin 8. Make sure no other bins are open (set their limits to zero). Parts that pass fall into bin 0; all other parts fall into bin 8 or bin 9.

**NESTED OR
OVERLAPPING BINS**   Enter the nominal value and limits for bin 0. For subsequent bins, enter only the limits, making sure the tighter tolerance parts use the lowest bins. If the limits are symmetrical, only enter the upper limit. Enter the QDR limit for bin 8. Make sure all other bins are closed. Parts that pass fall into one of the pass bins. Parts that fail the QDR test fall in bin 8 and parts that fall into no other bin fall into bin 9.

SEQUENTIAL BINS   For sequential bins with a single nominal value, follow the same procedure as for nested bins mentioned above. For sequential bins with multiple nominal values, enter the nominal value and limits for each open bin. If the limits are symmetrical, only enter the upper limit. Enter the QDR fail value for bin 8. Make sure that unused bins are closed (limits set to zero) and there are no unwanted gaps between bins. Parts that pass fall into one of the pass bins. Parts that fail the QDR test fall in bin 8 and parts that fall into no other bin fall into bin 9.

Binning Worksheet

Date: _____

Nominal value of component: _____

Tolerance to be sorted to: _____

Entered by: _____

Type of binning: Pass/Fail   Nested   Sequential

bin #	nom	+lim	-lim
0			
1			
2			
3			
4			
5			
6			
7			
8		xxxx	xxxx
9	xxxx	xxxx	xxxx

Option 01: GPIB/Handler Interface

GPIB Interface:

Detailed information on the GPIB interface and programming examples are available in the remote programming section.

Handler Interface:

Introduction

The handler interface for the SR720/715 allows the unit to be operated with external hardware to measure and physically sort components. Data lines for ten sorting bins are provided, as well as control lines (-START, -BUSY, -BDA) to coordinate measurements. For more information on bin setup procedures and options, refer to the binning section.

Timing Diagram:
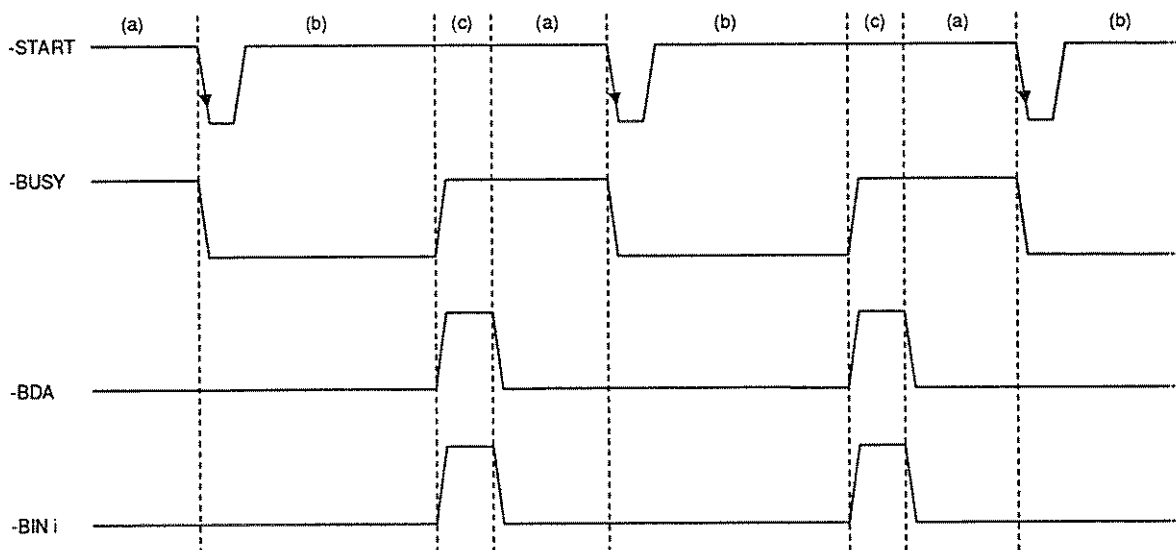
(a)   The SR720/715 is waiting for a trigger to start measuring. Previous bin data (if any) is still available.

(b)   A negative-going pulse on the -START line will trigger a reading. The -BUSY line will go low and stay low until the measurement is completed.

(c)   After measuring, the SR720/715 determines the proper bin to place the component. During this time the -BDA (Bin Data Available) line is activated to prevent reading invalid data.

   After the proper bin location has been selected, the -BDA line will go high, and the appropriate bin line will be pulled low (only a single bin line will be low at any one time). The external handler can now remove the component, place it in the specified location, and insert a new one into the fixture. The SR720/715 is now again in state (a).

Note: some handlers can be instructed to remove the component under test to the sorting area as soon as the -BUSY line goes high.

Mechanical Description:

The handler interface is part of the Option 01 GPIB/Handler board and is accessed via a 25 pin male connector on the rear of the SR720/715. A DB25 female connector, metal housing, and plastic sheath have been provided to simplify construction of a cable to the external handler.

Connector pinouts are as follows:

	Pin #
Bin 0:	13
Bin 1:	25
Bin 2:	12
Bin 3:	24
Bin 4:	11
Bin 5:	23
Bin 6:	10
Bin 7:	22
Bin 8:	9
Bin 9:	21
-BUSY:	8
-BDA:	20
-START:	3

Also: +5 supply   pins 7 and 19
        GND   pins 6 and 18

Electrical Description:

The trigger input (-START) line is active low and requires a pulse width of at least 50ns to activate (edge-triggered). 1N4148 diodes protect against voltages exceeding TTL levels. Outputs are provided by 7406 inverting buffers which have open-collector outputs and therefore need pull-up resistors for proper operation.

NOTE: Maximum High-level output voltage: 30 V
        Maximum Low-level output current: 40 mA

Example: When connecting the output to a 5V supply, the pull-up resistor should be no smaller than 5V/40mA = 125 ohms.

Flyback diodes should be added if the outputs are used to drive relay coils, but such a direct connection is not recommended. Ideally, opto-isolators should be used on all data lines to prevent noise from the handler from interfering with measurements.

DETAILED ACCURACY SPECIFICATION GUIDE

CONDITIONS

The following conditions must be met for the unit to meet its accuracy specifications

    1)   Warm up time: > 30 minutes
    2)   Temperature: 23 ± 5 °C
    3)   Fixture: Built in
    4)   Open & Short Circuit Calibration have been performed
    5)   D < 0.1 for Capacitance Measurements
           Q < 0.1 for Resistance Measurements
           Q > 10 for Inductance Measurements

ACCURACY EQUATIONS

The accuracy of a measurement is a function of the basic accuracy at that frequency, measurement rate, the signal amplitude, and where the impedance of the DUT is within the measurement range. The basic accuracy can be determined from the impedance graph or from the individual parametric graphs. Additional factors are determined by the measurement conditions and the impedance of the DUT. From these, the accuracy of a measurement in its optimal range can be calculated. See the following section for effects due to measurements made out of an optimal range.

IMPEDANCE ACCURACY

Accuracy of $Z = \pm [A \times K_i \times K_v + (K_h + K_l) \times 100]$ %

A = Basic Impedance Accuracy Factor from graph on next page.
If the unit is in the constant voltage (CV) mode, double the basic accuracy factor.

K_i = Integration Time Factor (see K_i Table below)

K_v = Drive Voltage Error Factor (see K_v Table below)

K_h, K_l = Extreme Range Error Term (see K_h, K_l Table below)

K_i Table

Meas Rate	Frequency	Z_m	K_i
slow,med	all		1
fast	100 Hz-1 kHz	6.25 Ω<Zm<400 kΩ	3
fast	all other		2

K_v Table

Vout (V rms)	K_v
1.0 - 0.55	1 / Vout
0.5 - 0.3	0.5 / Vout
0.25 - 0.15	0.25 / Vout
0.10	0.11/Volt

Note that K_v equals one for the primary drive voltages (1.0, 0.5 and 0.25 Vrms).

K_h & K_l Table

Frequency	K_l	K_h
100,120,1k Hz	(1 mΩ / Z_m)	(Z_m / 2 GΩ)
10 kHz	(1 mΩ / Z_m)	(Z_m / 1.5 GΩ)
100 kHz	(4 mΩ / Z_m)	(Z_m / 50 MΩ)

Z_m = the impedance of the device being measured.

Note that K_l is negligible for impedances above 100 Ω and K_h is negligible for impedances below 1 kΩ, both at all frequencies.

BASIC IMPEDANCE ACCURACY FACTOR

FREQUENCY (Hz)

NOTE: Upper number for SR720
Lower number for SR715.

For use with accuracy equations on
previous page.

R + Q ACCURACY

Accuracy of $R = \pm [A \times K_i \times K_v + (K_h + K_l) \times 100]$ %

A = Basic Resistance Accuracy Factor from graph.
For $|Q| > 0.1$, multiply the basic accuracy factor by $(1 + |Q|)$.
If the unit is in the constant voltage (CV) mode, double the basic accuracy factor.

K_i = Integration Time Factor (see K_i Table below)

K_v = Voltage Error Factor (see K_v table below).

K_h, K_l = Extreme Range Error Term (see K_h, K_l table below).

Accuracy of $Q = \pm [(A_r / 100) \times (1 + Q^2)]$

A_r = the accuracy of the Resistance measurement (above)

Note that the accuracy of Q is specified as a magnitude, NOT as a percent.

BASIC RESISTANCE ACCURACY FACTOR
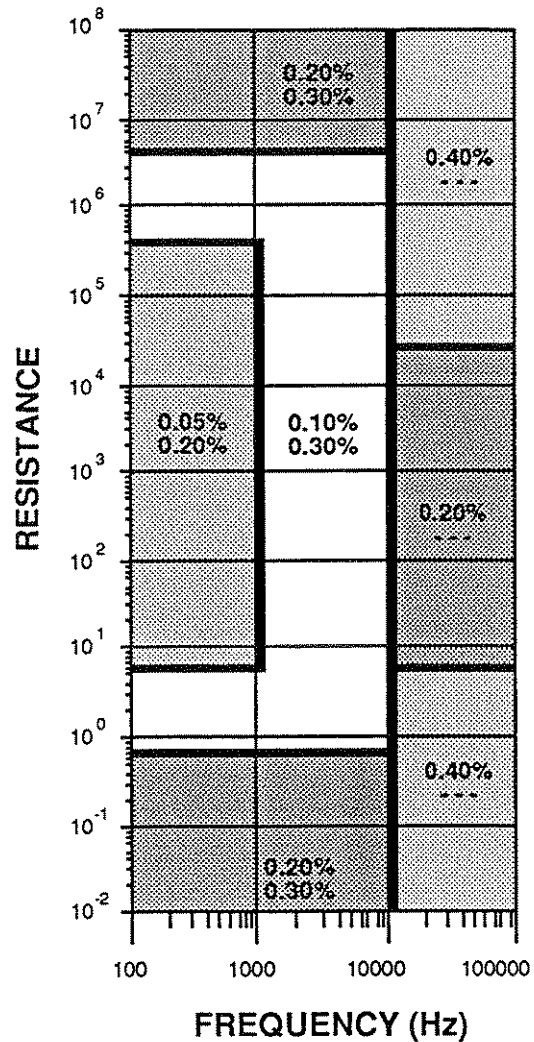
FREQUENCY (Hz)

NOTE: Upper number SR720.
Lower number SR715.

K_i Table

Meas Rate	Frequency	Z_m	K_i
slow, med	all		1
fast	100 Hz-1 kHz	6.25 Ω<Z_m<400 kΩ	3
fast	all other		2

Z_m = the impedance (resistance) of the device being measured.

K_v Table

Vout (V rms)	K_v
1.0 - 0.55	1 / Vout
0.5 - 0.3	0.5 / Vout
0.25 - 0.15	0.25 / Vout
0.10	0.11/Volt

Note that K_v equals one for the primary drive voltages (1.0, 0.5 and 0.25 Vrms).

K_h & K_l Table

Frequency	K_l	K_h
100,120,1k Hz	(1 mΩ / R_m)	(R_m / 2 GΩ)
10 kHz	(1 mΩ / R_m)	(R_m / 1.5 GΩ)
100 kHz	(4 mΩ / R_m)	(R_m / 50 MΩ)

R_m = the resistance of the device being measured.

Note that K_l is negligible for resistances above 100 Ω and K_h is negligible for resistances below 1 kΩ at all frequencies.

4-4

L + Q ACCURACY

Accuracy of $L = \pm [A \times K_i \times K_v + (K_h + K_l) \times 100]$ %

    A = Basic Inductance Accuracy Factor from graph.
For Q < 10, multiply the basic accuracy factor by $(1 + 1/Q)$.
If the unit is in the constant voltage (CV) mode, double the basic accuracy factor.

    K_i = Integration Time Factor (see K_i Table below)

    K_v = Voltage Error Factor (see K_v table below).

    K_h, K_l = Extreme Range Error Term (see K_h, K_l table below).

Accuracy of $Q = \pm [(A_l / 100) \times (1 + Q^2)]$

    A_l = the accuracy of the Inductance measurement (above)

Note that the accuracy of Q is specified as a magnitude, NOT as a percent.

BASIC INDUCTANCE ACCURACY FACTOR

FREQUENCY (Hz)

NOTE: Upper number SR720.
Lower number SR715.

K_i Table

Meas Rate	Frequency	Z_m	K_i
slow, med	all		1
fast	100 Hz-1 kHz	6.25 Ω<Z_m<400 kΩ	3
fast	all other		2

$Z_m = 2\pi f L$ = impedance of device

K_v Table

Vout (V rms)	K_v
1.0 - 0.55	1 / Vout
0.5 - 0.3	0.5 / Vout
0.25 - 0.15	0.25 / Vout
0.10	0.11/Volt

Note that K_v equals one for the primary drive voltages (1.0, 0.5 and 0.25 Vrms).

K_h & K_l Table

Frequency	K_l	K_h
100,120 Hz	(1 µH / L_m)	(L_m / 2.6 MH)
1 kHz	(0.1 µH / L_m)	(L_m / 260 kH)
10 kHz	(0.02 µH / L_m)	(L_m / 10 kH)
100 kHz	(0.02 µH / L_m)	(L_m / 100 H)

L_m = the inductance of the device being measured.

Note that K_l is negligible for inductances above 15.9/f H and K_h is negligible for inductances below 159./f kH, where f is the output frequency.

C + D ACCURACY

Accuracy of $C = \pm [A \times K_i \times K_v + (K_h + K_l) \times 100]$ %

A = Basic Capacitance Accuracy Factor from graph.
For D > 0.1, multiply the basic accuracy factor by $(1 + D)$.
If the unit is in the constant voltage (CV) mode or under internal or external bias, double the basic accuracy factor.
K_i = Integration Time Factor (see K_i Table below)
K_v = Voltage Error Factor (see K_v table below).
K_h, K_l = Extreme Range Error Term (see K_h, K_l table below).

Accuracy of $D = \pm [A_c / 100]$

A_c = the accuracy of the capacitance measurement (above)

Note that the accuracy of D is specified as a magnitude, NOT as a percent.

BASIC CAPACITANCE ACCURACY FACTOR

FREQUENCY (Hz)

NOTE: Upper number SR720.
Lower number SR715.

K_h & K_l Table

Frequency	K_l	K_h
100,120 Hz	$(2 \text{ pF} / C_m)$	$(C_m / 1600 \text{ mF})$
1 kHz	$(0.1 \text{ pF} / C_m)$	$(C_m / 160 \text{ mF})$
10 kHz	$(0.01 \text{ pF} / C_m)$	$(C_m / 16 \text{ mF})$
100 kHz	$(0.02 \text{ pF} / C_m)$	$(C_m / 200 \text{ } \mu F)$

C_m = the capacitance of the device being measured.

Note that K_l is negligible for capacitances less than 1590/f μF and K_h is negligible for capacitances above 159/f μF, where f is the output frequency.

K_i Table

Meas Rate	Frequency	Z_m	K_i
slow, med	all		1
fast	100 Hz-1 kHz	6.25 Ω<Z_m<400 kΩ	3
fast	all other		2

$Z_m = 1/2\pi f C$ = impedance of device

K_v Table

Vout (V rms)	K_v
1.0 - 0.55	1 / Vout
0.5 - 0.3	0.5 / Vout
0.25 - 0.15	0.25 / Vout
0.10	0.11/Volt

Note that K_v equals one for the primary drive voltages (1.0, 0.5 and 0.25 Vrms).
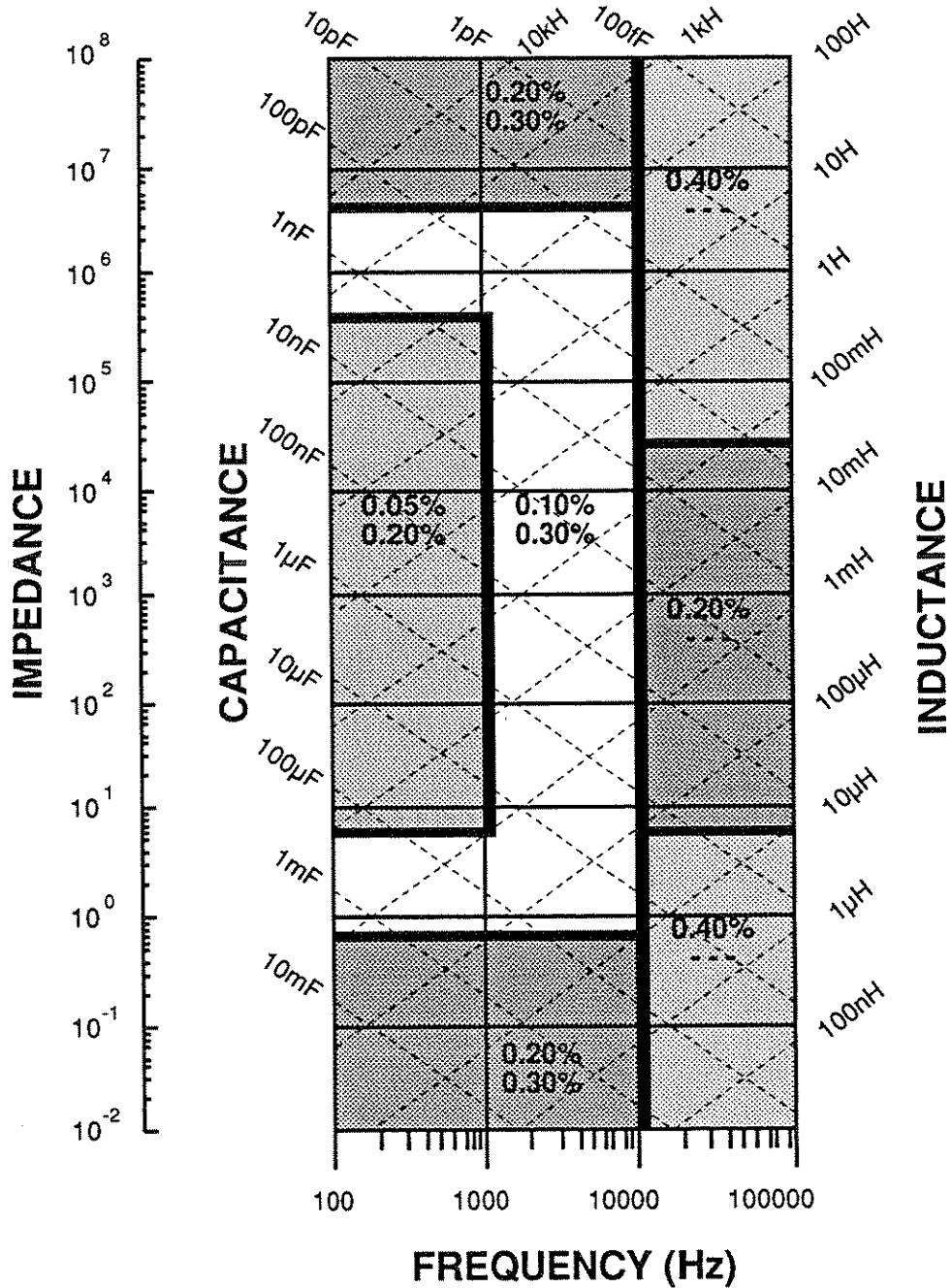
C + R ACCURACY

Accuracy of $C = \pm [A \times K_i \times K_v + (K_h + K_l) \times 100]$ %

    A = Basic Capacitance Accuracy Factor from graph on page 4-6. If the unit is in the constant voltage (CV) mode, or under internal or external bias, double the basic accuracy factor.

    K_i = Integration Time Factor (see K_i Table below)
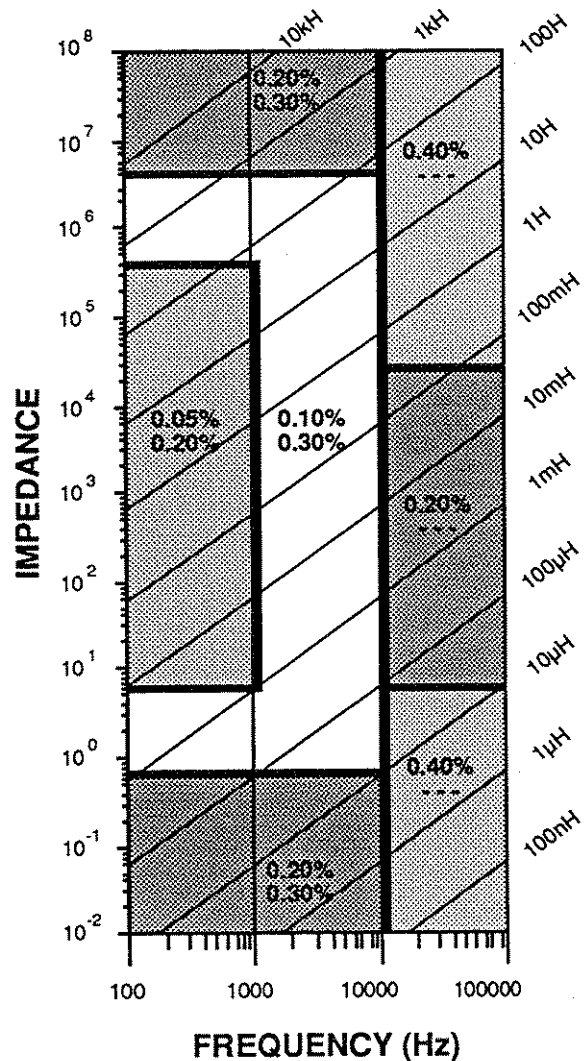
    K_v = Voltage Error Factor (see K_v table below).

    K_h, K_l = Extreme Range Error Term (see K_h, K_l table below).

Accuracy of $R = \pm [A_c \times (1+1/|D|)]$ %

    A_c = the accuracy of the capacitance measurement (above) and $D = R / (2\pi fC)$

Note that for small values of D it is possible to have negative resistance values because the resistance accuracy depends on the magnitude of C, not of R.

For D > 0.1 , the impedance accuracy must first be calculated. To do this, first calculate the impedance of the DUT by adding the resistive and capacitive elements, either in series or in parallel, as is appropriate. Use the impedance accuracy graph and equation on page 4-2 to obtain an impedance accuracy. The accuracy of C and R are calculated from the impedance accuracy as follows:

Accuracy of $C = \pm [Zac \times (1 + |D|)]$ %
Accuracy of $R = \pm [Zac \times (1 + 1/|D|)]$ %

where Zac is the impedance accuracy.

If the unit is in the constant voltage (CV) mode or under internal or external bias, double the basic accuracy for Z.

K_i Table

Meas Rate	Frequency	Z_m	K_i
slow, med	all		1
fast	100 Hz-1 kHz	6.25 Ω<Z_m<400 kΩ	3
fast	all other		2

$Z_m = 1/2\pi fC$ = impedance of device

K_v Table

Vout (V rms)	K_v
1.0 - 0.55	1 / Vout
0.5 - 0.3	0.5 / Vout
0.25 - 0.15	0.25 / Vout
0.10	0.11/Volt

Note that K_v equals one for the primary drive voltages (1.0, 0.5 and 0.25 Vrms).

K_h & K_l Table

Frequency	K_l	K_h
100,120 Hz	(2 pF / C_m)	(C_m / 2000 mF)
1 KHz	(0.1 pF / C_m)	(C_m / 200 mF)
10 KHz	(0.01 pF / C_m)	(C_m / 10 mF)
100 KHz	(0.01 pF / C_m)	(C_m / 100 μF)

C_m = the capacitance of the device being measured.

Note that K_l is negligible for capacitances less than 1590/f μF and K_h is negligible for capacitances above 159/f μF, where f is the output frequency.

Accuracy when Holding a non-optimal Range

When a component is measured outside of its nominal range (in range hold), the accuracy of the measurement is reduced. The nominal ranges are defined as approximately four times above and below the nominal impedance value. 100kHz values apply to the SR720 only.

Range		Nominal Impedance Range	
R3		$6.25\,\Omega$ - $100\,\Omega$	
R2		$100\,\Omega$ - $1.6\,k\Omega$	
R1		$1.6\,k\Omega$ - $25.6\,k\Omega$	
R0	100Hz - 10kHz	$25.6\,k\Omega$ - $400\,k\Omega$	(R0 is not defined for 100 kHz)

Components that are measured while autoranging have only one set of extreme range terms (K_h, K_l) per frequency. For components measured in range hold the values of K_h and K_l are different for each range. These values are listed below for R, L, C and Z.

Impedance $K_l = Z_l / Z_m$ $K_h = Z_h / Z_m$ where Z_m = the impedance of the device being measured and Z_l & Z_h are given below.

Resistance $K_l = R_l / R_m$ $K_h = R_h / R_m$ where R_m = the resistance of the device being measured and R_l & R_h are given below.

Frequency	Z_l, R_l				Z_h, R_h			
	R3	R2	R1	R0	R3	R2	R1	R0
100,120,1k Hz	$1\,m\Omega$	$0.02\,\Omega$	$.2\,\Omega$	$4\,\Omega$	$400\,k\Omega$	$6.5\,M\Omega$	$100\,M\Omega$	$2\,G\Omega$
10 kHz	$1\,m\Omega$	$0.02\,\Omega$	$.2\,\Omega$	$6\,\Omega$	$400\,k\Omega$	$6.5\,M\Omega$	$100\,M\Omega$	$1.5\,G\Omega$
100 kHz	$4\,m\Omega$	$0.03\,\Omega$	$.4\,\Omega$	xxx	$200\,k\Omega$	$3\,M\Omega$	$50\,M\Omega$	xxx

Inductance $K_l = L_l / L_m$ $K_h = L_h / L_m$ where L_m = the inductance of the device being measured and L_l & L_h are given below.

Frequency	L_l				L_h			
	R3	R2	R1	R0	R3	R2	R1	R0
100,120 Hz	$1\,\mu H$	$20\,\mu H$	$300\,\mu H$	$5\,mH$	$630\,H$	$10\,kH$	$160\,kH$	$2.6\,MH$
1 kHz	$.1\,\mu H$	$2\,\mu H$	$30\,\mu H$	$500\,\mu H$	$63\,H$	$1\,kH$	$16\,kH$	$.26\,MH$
10 kHz	$.02\,\mu H$	$.32\,\mu H$	$5\,\mu H$	$50\,\mu H$	$6.3\,H$	$100\,H$	$1\,kH$	$10\,kH$
100 kHz	$.02\,\mu H$	$.1\,\mu H$	$2\,\mu H$	xxx	$3.2\,H$	$10\,H$	$100\,H$	xxx

Capacitance $K_l = C_l / C_m$ $K_h = C_h / C_m$ where C_m = the inductance of the device being measured and C_l & C_h are given below.

Frequency	C_l				C_h			
	R3	R2	R1	R0	R3	R2	R1	R0
100,120 Hz	$4\,nF$	$240\,pF$	$16\,pF$	$2\,pF$	$1600\,mF$	$80\,mF$	$6.7\,mF$	$400\,\mu F$
1 kHz	$400\,pF$	$24\,pF$	$1.6\,pF$	$.1\,pf$	$160\,mF$	$8\,mF$	$670\,\mu F$	$40\,\mu F$
10 kHz	$40\,pF$	$2.4\,pF$	$.16\,pF$	$.01pF$	$16\,mF$	$800\,\mu F$	$40\,\mu F$	$2.6\,\mu F$
100 kHz	$8\,pf$	$2.4\,pF$	$.02\,pf$	xxx	$200\,\mu F$	$80\,\mu F$	$4\,\mu F$	xxx

INTRODUCTION

The SR715 / SR720 LCR meters may be remotely programmed via either the RS232 or GPIB (IEEE-488) interfaces. Any computer supporting either of these interfaces may be used with the SR715/720. Both interfaces are simultaneously active. The SR715/720 will respond to commands from either interface and return answers to the interface from which the command came. All front and rear panel features (except power) may be controlled.

COMMUNICATING WITH GPIB

The SR715/720 supports the IEEE-488.1 (1978) interface standard. It also supports the required common commands of the IEEE-488.2 (1987) standard. Before attempting to communicate with the SR715/720 over the GPIB interface, the SR715/720's device address must be set. The address is set by the rear panel switches SW2. The address may be set between 0 and 30 by setting the binary value of the address on switches A0 to A4. Each switch may have the value 0 (down) or 1 (up). The address is set by the formula: Address = A0 + 2*A1 + 4*A2 + 8*A3 + 16*A4.

COMMUNICATING WITH RS232

The SR715/720 is configured as a DCE (transmit on pin 3, receive on pin 2) and supports CTS/DTR hardware handshaking. The CTS signal (pin 5) is an output indicating that the SR715/720 is ready, while the DTR signal (pin 20) is an input that is used to control the SR715/720's transmitting. If desired, the handshake pins may be ignored and a simple 3 wire interface (pins 2,3 and 7) may be used. Before communicating with the SR715/720 the RS232 characteristics must be set. The RS232 interface is configured using the rear panel switches SW1. The first three switches set the baud rate to 300, 600, 1200, 2400, 4800, or 9600 baud. Parity may be enabled or disabled, and set to even or odd. And, the number of bits in a data byte may be set to 7 or 8.

Sw1 Settings For Rs232 Parameters

bit0	bit1	bit2	Baud Rate
0	0	0	300
1	0	0	600
0	1	0	1200
1	1	0	2400
0	0	1	4800
1	0	1	9600
0	1	1	19.2 k

bit3	1	parity on
	0	parity off
bit4	1	even parity
	0	odd parity
bit5	1	8 data bits
	0	7 data bits

Note; the SR715/720 must be set to 8 data bits if the binary data output formats are to be used.

FRONT PANEL LEDS

To assist in programming, the SR715/720 has 3 front panel status LEDs. The ACT LED flashes whenever a character is received or sent over either interface. The ERR LED flashes when an error has been detected, such as an illegal command, or parameter out of range. The REM LED is lit whenever the SR715/720 is in a remote state (front panel locked out).

COMMAND SYNTAX

Communications with the SR715/720 use ASCII characters. Commands may be in either UPPER or lower case and may contain any number of embedded space characters. A command to the SR715/720 consists of a four character command mnemonic, arguments if necessary, and a command terminator. The terminator may be either a carriage return <cr> or linefeed <lf> on RS232, or a linefeed <lf> or EOI on GPIB. No command processing occurs until a command terminator is received. All commands function identically on GPIB and RS232. Command mnemonics beginning with an asterisk "*" are IEEE-488.2 (1987) defined common commands. These commands also function identically on RS232. Commands may require one or more parameters. Multiple parameters are separated by commas ",".

Multiple commands may be sent on one command line by separating them by semicolons ";". The difference between sending several commands on the same line and sending several independent commands is that when a command line is parsed and executed the entire line is executed before any other device action proceeds.

There is no need to wait between commands. The SR715/720 has a 256 character input buffer and processes commands in the order received. If the buffer fills up the SR715/720 will hold off handshaking on the GPIB and attempt to hold off handshaking on RS232. If the buffer overflows the buffer will be cleared and an error reported. Similarly, the SR715/720 has a 256 character output buffer to store output until the host computer is ready to receive it. If the output buffer fills up it is cleared and an error reported. The GPIB output buffer may be cleared by using the Device Clear universal command.

The present value of a particular parameter may be determined by querying the SR715/720 for its value. A query is formed by appending a question mark "?" to the command mnemonic and omitting the desired parameter from the command. If multiple queries are sent on one command line (separated by semicolons, of course) the answers will be returned in a single response line with the individual responses separated by semicolons. The default response terminator that the SR715/720 sends with any answer to a query is carriage return-linefeed <cr><lf> on RS232 and linefeed plus EOI on GPIB, except for binary answers which are terminated by a single <lf> on both interfaces. All commands return integer results except as noted in individual command descriptions.

Examples of Command Formats

FREQ 2 <lf>	Sets the drive frequency to 1000 Hz (1 parameter).
FREQ? <lf>	Queries the drive frequency (query of 1 parameter command).
BLIM 0,3,1000<lf>	Sets the upper limit of bin 3 to 1000Ω (3 parameters).
BLIM? 0,3<lf>	Queries the upper limit of bin 3 (query of 3 parameter command).
*IDN? <lf>	Queries the device identification (query, no parameters).

*TRG <lf>	Triggers a measurement (no parameters).
FREQ 1 ;FREQ? <lf>	Sets frequency to 120Hz (1) then queries the frequency.

PROGRAMMING ERRORS

The SR715/720 reports two types of errors that may occur during command execution: command errors and execution errors. Command errors are errors in the command syntax. For example, unrecognized commands, illegal queries, lack of terminators, and non-numeric arguments are examples of command errors. Execution errors are errors that occur during the execution of syntactically correct commands. For example, out of range parameters and commands that are illegal for a particular mode of operation are classified as execution errors.

NO COMMAND BIT

The NO COMMAND bit is a bit in the serial poll register that indicates that there no commands waiting to be executed in the input queue. This bit is reset when a complete command is received in the input queue and is set when all of the commands in the queue have been executed. This bit is useful in determining when all of the commands sent to the SR715/720 have been executed. This is convenient because some commands, such as taking a measurement, or autocalibration, take a long time to execute and there is no other way of determining when they are done. The NO COMMAND bit may be read while commands are being executed by doing a GPIB serial poll. There is no way to read this bit over RS232. Note that using the *STB? query to read this bit will always return the value 0 because it will always return an answer while a command is executing- the *STB? command itself!

DETAILED COMMAND LIST

The four letter mnemonic in each command sequence specifies the command. The rest of the sequence consists of parameters. Multiple parameters are separated by commas. Parameters shown in {} are optional or may be queried while those not in {} are required. Commands that may be queried have a question mark ? in parentheses (?) after the mnemonic. Commands that may ONLY be queried have a ? after the mnemonic. Commands that MAY NOT be queried have no ?. Do not send ( ) or { } as part of the command.

All variables may be expressed in integer, floating point or exponential formats (i.e., the number five can be either 5, 5.0, or .5E1). The variables i and j are usually integer values, while the variable x is a real number.

MEASUREMENT SETUP COMMANDS

$STL(?) {i}	The $STL command sets the SR715/720's settling time to i milliseconds, where i is between 2 and 99. The $STL? query returns the settling time.
AVGM(?) {i}	The AVGM command sets averaging off (i=0) and on (i=1). The AVGM? query returns the averaging status.
BIAS(?) {i}	The BIAS command sets the SR715/720's DC bias to off (i=0), internal (i=1), or external (i=2). This command will return an error if the SR715/720 is not set to a capacitance mode (C+D or C+R). The BIAS? query returns the present bias status.
CIRC(?) {i}	The CIRC command sets the SR715/720's equivalent circuit to series (i=0) or parallel (i=1). The CIRC? query returns the equivalent circuit setting.
CONV(?) {i}	The CONV command sets constant voltage off (i=0) or on (i=1). The CONV? query returns the constant voltage setting.
FREQ(?) {i}	The FREQ command sets the drive frequency to 100 Hz (i=0), 120 Hz (i=1), 1 kHz (i=2), 10 kHz (i=3), or 100 kHz (i=4, SR720 only). The FREQ? query returns the drive frequency.
MMOD(?) {i}	The MMOD command sets the measurement mode to continuous (i=0), or triggered (i=1). The MMOD? query returns the measurement mode setting.
NAVG(?) {i}	The NAVG command sets the number of measurements to be averaged when averaging is enabled (see the AVGM command). i may be between 2 and 10. The NAVG? query returns the number of averages.
PMOD(?) {i}	The PMOD command sets the parameter mode to Auto (i=0), R+Q (i=1), L+Q (i=2), C+D (i=3), or C+R (i=4). The PMOD? query returns the present parameter mode. Note that relative measurements and binning are not allowed in Auto parameter mode.
RATE(?) {i}	Sets the measurement rate to fast (i=0), medium (i=1), or slow (i=2). The RATE? query returns the measurement rate s setting.
RNGE(?) {i}	The RNGE command sets the measurement range to 100 kΩ (i=0), 6.4 kΩ (i=1), 400 Ω (i=2), or 25 Ω (i=3). This command automatically enables range hold (see the RNGH command). The 100 kΩ range is not allowed at 100 kHz drive frequency. The RNGE? query returns the range.

RNGH(?) {i}   The RNGH command disables (i=0) and enables (i=1) range hold. When
                                   range hold is disabled the SR715/720 will autorange. The RNGH? query re-
                                   turns the range hold status.

VOLT(?) {x}   The VOLT command sets the drive voltage to x volts. x may range from 0.1 V
                                   to 1.0 V and is rounded to the nearest 0.05 V. The VOLT? query returns the
                                   drive voltage.

MEASUREMENT CONTROL COMMANDS

PREL(?) {x}   The PREL command sets the relative parameter value for deviation and per-
                                   cent deviation measurements to x. This command will return an error if the
                                   SR715/720 is set to AUTO parameter mode. The units of x are Ohms in R+Q
                                   mode, Henrys in L+Q mode, and Farads in C+D and C+R modes. The
                                   PREL? query returns the present nominal value.

STRT   The STRT command starts a measurement. If a measurement is already in
                                   progress, this command is ignored.

STOP   The STOP command stops the current measurement.

*TRG   The *TRG IEEE common command functions the same as the STRT com-
                                   mand.

MEASUREMENT RESULT COMMANDS

The following commands return the results of the SR715/720's measurements. The results may be returned in
either ASCII or binary format, and may or may not return measurement status information.

OUTF(?) {i}   Set OUTF command sets the format for the X commands to Verbose ASCII
                                   (i=0), Concise ASCII (i=1), Verbose Binary (i=2), or Concise Binary (i=3). The
                                   verbose formats return both measurement value and status information,
                                   while the concise formats return only measurement values. The formats are
                                   detailed below. The OUTF? query returns the present output format.

Verbose ASCII   This format returns both status and measurement data as a string of ASCII
                characters. The byte ordering and their meanings are given below.

Byte	Character	Meaning
1	status	The first byte is the measurement status. The first charac-ter can be any of the following:
	G	Measurement good. No errors.
	I	Invalid measurement, no measurement completed, A/D converter errors.
	L	Measurement overloaded.
	U	Underrange. The measurement value is below the nominal range of values for this measurement range.
	O	Overrange. The measurement value is above the nominal range of values for this measurement range.
	R	Out of Range. The value is above the SR715/720's ability to measure on this measurement range.

Byte	Character	Meaning
2	0,1,2,3	The range on which this measurement was taken.
3	R,L,C	The major parameter type if querying the major value.
	Q,D,R	The minor parameter type if querying the minor value.
4-N	value	The measurement value in exponential notation. If the measurement is invalid, overloaded, or out of range 9.9999E20 is returned. The units of the value are Ohms for R's, Henrys for L's, Farads for C's, and percent for percent deviation.

An example of a verbose ASCII response is the string "G2R1.234E-6".

Concise ASCII   This format returns only the measurement value described for verbose ASCII results. An example of a concise ASCII response is the string "1.234E-6".

Verbose Binary   This format returns both status and measurement values as a sequence of 8-bit binary bytes. The bytes returned are detailed below:

Byte	Value	Meaning
1,2	'#0'	The ASCII values # and 0 (23h and 30h) are header information indicating IEEE binary block data output.
3	status	An encoded status byte. The bit values are given by:
	xxxx0000	Measurement Good. No errors.
	xxxx0001	Invalid measurement, no measurement, A/D error.
	xxxx0010	Measurement overloaded.
	xxxx0100	Underrange. The measurement value is below the nominal range of values for this measurement range.
	xxxx1000	Overrange. The measurement value is above the nominal range of values for this measurement range.
	xxxx1111	Out of Range. The value is above the SR715/720's ability to measure on this measurement range.
	xx00xxxx	R+Q
	xx01xxxx	L+Q
	xx10xxxx	C+D
	xx11xxxx	C+R
	00xxxxxx	Range 0
	01xxxxxx	Range 1
	10xxxxxx	Range 2
	11xxxxxx	Range 3
4-7	value	The measurement value is returned in 4 byte (32 bit) IEEE standard single precision floating point format. The least significant byte is sent first (the same as PC format). The value 9.9999E20 returned if the measurement is invalid, overloaded, or out of range.
8	linefeed	Linefeed (10h) is the result terminator (sent with EOI on GPIB).

Concise Binary	The same format as verbose binary except that the status byte (byte 3) is not sent.

Note: When using the RS232 interface, the SR715/720 must be set to 8 data bits if the binary data output formats are to be used.

XALL?	The XALL? query returns the value of the major parameter, minor parameter, and bin number. The three values are returned in the format set by the OUTF command. The 3 responses are separated by commas in the ASCII formats. There are no response separators in the binary formats. Because all necessary status information is sent with the major and minor parameters, **no status information is sent with the bin number in any format.** The bin number is a single byte binary integer in the binary formats (**not a 32 bit floating point number**).
XBIN?	The XBIN? query returns the bin number of the present measurement. If binning is not active, or if the measurement is invalid, the value 99 will be returned. In the binary formats the value of the bin number is returned as a single byte binary integer (**not a 32 bit floating point number**).
XDLT?	The XDLT? query returns the deviation between the major parameter and the relative value (see the PREL command). If the relative value is zero, or if the parameter mode is set to AUTO, an error will be generated. The value is returned in the format set by the OUTF command.
XMAJ?	The XMAJ? query returns the value of the major parameter. The value is returned in the format set by the OUTF command.
XMIN?	The XMIN? query returns the value of the minor parameter. The value is returned in the format set by the OUTF command.
XPCT?	The XPCT? query returns the percent deviation between the major parameter and the nominal value (see the PREL command). If the nominal value is zero, or if the parameter mode is set to AUTO, an error will be generated. The value is returned in the format set by the OUTF command.

BINNING COMMANDS

BCLR	The BCLR command clears the nominal values and limits for all of the bins. The BCLR command also disables binning.
BING(?) {i}	The BING command disables (i=0) and enables (i=1) binning. If no bins are open, or if the SR715/720 is in AUTO parameter mode, an error will be generated.
BLIM(?) i,j {,x}	The BLIM command sets the SR715/720's bin limits. If i = 0 the upper limit of bin j is set to x %. If i = 1 the lower limit of bin j is set to x %. j may range from 0 to 7. The upper limit of a bin must be set before the lower limit, and the lower limit must be less than or equal to the upper limit. If no lower limit is set,

the SR715/720 will use the negative of the upper limit as the lower limit (the bin will be symmetrical about the nominal value). The BLIM? i,j query returns the upper (i=0) or lower (i=1) limit of bin j.

BNOM(?) i {,x}

The BNOM command sets the nominal value of bin i to x. i may range from 0 to 8 (bin 8 is the QDR fail bin). If no nominal value is set for a bin, the SR715/720 will use the nominal value from the next lowest numbered bin with a non-zero nominal value (several bins can have the same nominal value without entering the value for each bin). The lowest numbered active bin must have its nominal value set. Bin 0 must always be set for binning to be enabled. The BNOM? i query returns the nominal value for bin i.

SETUP and CONTROL COMMANDS

✻IDN?

The ✻IDN? common query returns the SR715/720's device configuration. This string is in the format: "StanfordResearchSystems,SR7XX,YYYYY,ZZZ". Where "YYYYY" is the five digit serial number of the unit, and "ZZZ" is the 3 digit firmware revision number.

✻OPC(?)

The ✻OPC (operation complete) common command/query is used to synchronize command execution to the SR715/720's measurement process. The ✻OPC command will set a bit in the Standard Event Status Byte when all measurements in progress are complete. The ✻OPC? query will return the value 1 when all measurements in progress are complete. For example, the commands STRT;✻OPC? would start a measurement and return a 1 when it was done. The controlling program would then know that the answer was ready to retrieved.

✻RCL i

The ✻RCL command recalls stored setting number i, where i may range from 0 to 9. If the stored setting is corrupt or has never been stored, an execution error will be generated. ✻RCL0 recalls the default setup.

✻RST

The ✻RST common command resets the SR715/720 to its default configurations.

✻SAV i

The ✻SAV command saves the current instrument settings as setting number i (1-9).

✻WAI

The ✻WAI common command is a synchronization command that halts further command processing until all measurements in progress are complete. For example, the commands STRT;✻WAI;XALL? would start a measurement, halt further command processing until the measurement was complete, and then execute the XALL? command to return the measurement result.

STATUS REPORTING COMMANDS

*CLS

The *CLS common command clears all status registers. This command **does not** affect the status enable registers.

*ESE (?) {i}

The *ESE i command sets the standard event status byte enable register to the decimal value i (0-255). The *ESE? query returns the value (0-255) of the status byte enable register.

*ESR? {i}

The *ESR? command queries the value of the standard event status byte. The value is returned as a decimal number from 0 to 255. The *ESR? i query returns the value (0 or 1) of bit i (0-7). Reading the entire byte will clear it while reading bit i will clear just bit i.

*PSC (?) {i}

The *PSC common command sets the value of the power-on status clear bit. If i = 1 the power on status clear bit is set and all status registers and enable registers are cleared on power up. If i = 0 the bit is cleared and the status enable registers maintain their values at power down. This allows the production of a service request at power up.

*SRE (?) {i}

The *SRE i command sets the serial poll enable register to the decimal value i (0-255). The *SRE? query returns the value (0-255) of the serial poll enable register.

*STB? {i}

The *STB? command queries the value of the serial poll byte. The value is returned as a decimal number from 0 to 255. The *STB? i command queries the value (0 or 1) of bit i (0-7). Reading this byte has no effect on its value.

SENA (?) {i}

The SENA command sets the LCR status enable register to the decimal value i (0-255). The SENA? query returns the value (0-255) of the LCR status enable register.

STAT? {i}

The STAT? query reads the value of the LCR status byte. The value is returned as a decimal number from 0 to 255. The STAT? i returns the value (0 or 1) of bit i (0-7). Reading this register will clear it while reading bit i will clear just bit i.

HARDWARE TEST AND CALIBRATION COMMANDS

NOTE: These commands are primarily intended for factory calibration use and should never be needed during normal operation. See the CALIBRATION section for details on calibrating the unit. **Incorrect use of some of these commands can destroy the calibration of the SR715/720.**

*CAL? i

The *CAL? i common query initiates the SR715/720's self calibration routines. When the calibration is complete the status of the calibration is returned. The parameter i determines which calibration will be performed. If i = 0 the Short Circuit calibration will be done. If i = 1 the Open Circuit calibration will be done. And, if i = 2 the Standard Resistor calibration will be done. The calibration status may have the following return values:

Status	Meaning
0	No Error
1	Measurement Error (overload, etc.).
2	Short Circuit Calibration Error. The short circuit impedance was too high.
3	Open Circuit Calibration Error. The open circuit impedance was too low.
4	Standard Resistor Calibration Error. The standard resistor calibration value was out of range.

*TST?

The *TST? common query runs the SR715/720's internal self-tests. After the tests are complete, the test status is returned. The test status may have the following values:

Status	Meaning
0	No Error
1	CPU Error. There is a problem with the CPU.
2	Code Error. The ROM firmware has a checksum error.
3	System RAM Error. The system RAM has failed its memory test.
4	Calibration Data Error. The calibration data is no longer valid.
5	Clock Generator Error. The drive frequency clock failed its test.
6	ADC Error. The A/D converter or multiplier failed its test.
7	Drive Error. The sine wave output amplitude control failed its test.
8	Instrumentation Amp Error. The input instrumentation amplifier failed its test.
9	Output Error. The output impedance selector failed its test. **This error may occur if there is a part in the fixture when the test is executed.**

$CBT(?) i {,j}

The $CBT command sets amplitude calbyte i to the value j. i may range from 0 to 94, and j from 0 to 255.

$CFT(?) i {,x}

The $CFT command sets floating point calbyte i to the floating point value x.

$CMJ(?) {x}

The $CMJ command sets the major parameter to be used in the standard resistor calibration to x Ohms. If x differs by more than 10% from the nominal value of the range being calibrated an error is generated.

$CMN(?) {x}

The $CMN command sets the minor parameter value for standard resistor calibration. x has units of ppm and may range between ±9999.9 ppm with 0.1 ppm resolution. The $CMN? query reads the current minor parameter.

$CNT?   Reads the raw A/D converter counts when in diagnostic mode.

$CRN(?) {i}   The $CRN command sets the range to be calibrated in standard resistor cali-
                         bration to range i. The $CRN? query reads the present calibration range.

$CTS? i   The $CTS? query returns the raw A/D converter counts during normal meas-
                         urements. i = 0 and i = 1 return the inphase and quadrature counts for the
                         voltage measurement, while i = 2 and i = 3 return the inphase and quadrature
                         counts for the current measurement.

$DIA(?) {i}   The $DIA command disables (i=0) and enables (i=1) diagnostic mode meas-
                         urements. The $DIA? query returns the diagnostic mode status.

$FRQ(?) {x}   The $FRQ command sets the frequency correction factor to x ppm. x is
                         rounded to the nearest 0.1 ppm and must be less than ±10000 ppm. The
                         $FRQ? query returns the current frequency correction factor.

$GAN(?) {i}   The $GAN command sets the instrumentation amplifier gain to setting i when
                         the instrument is in diagnostic mode. The $GAN? query returns the present
                         gain setting.

$INP(?) {i}   The $INP command sets the input multiplexer to input i when the instrument
                         is in diagnostic mode. The $INP? query returns the present input setting.

$INT(?) {i}   The $INT command sets the measurement time to i cycles of the drive wave-
                         form. i may range between 1 and 10000 cycles, restricted so that the total
                         measurement time is less than 10 seconds. The $INT? query returns the
                         present measurement time.

$PHS(?) {i}   The $PHS command sets the phase of the measurement relative to the drive
                         signal when the instrument is in diagnostic mode. The phase can be 0° (i=0),
                         180° (i=1), 90° (i=2), or 270° (i=3). The $PHS? query returns the present
                         measurement phase.

$RND(?) {i}   The $RND command sets the rounding of the measurement results. If i = -1
                         the SR715/720 automatically rounds to the correct number of digits given the
                         current range, value, etc.. If i = 0, 1, 2, or 3 the measurement result will be
                         rounded to 5 - i digits of resolution. The $RND? query returns the current
                         rounding setting.

STATUS BYTE DEFINITIONS

The SR715/720 reports on its status by means of three status bytes: the serial poll byte, the standard status byte, and the LCR status byte.

On power on the SR715/720 may either clear all of its status enable registers or maintain them in the state they were in on power down. The action taken is set by the *PSC command and allows things such as SRQ on power up .

SERIAL POLL
STATUS BYTE

bit	name	usage
0	Ready	The SR7XX is ready to perform a measurement.
1	unused	
2	unused	
3	LCR	An unmasked bit in the LCR status register has been set.
4	MAV	The gpib output queue is non-empty
5	ESB	An unmasked bit in the standard status byte has been set.
6	RQS/MSS	SRQ (Service Request)bit.
7	No Command	There are no unexecuted commands in the input queue

The LCR and ESB bits are set whenever any unmasked bit in their respective status registers is set. A bit is unmasked by setting the corresponding bit in the corresponding enable register to 1. The Serial Poll Status bits are not cleared until the condition which set the bit is cleared. Thus, these bits give a constant summary of the unmasked or enabled status bits. A service request will be generated whenever an unmasked bit in the Serial Poll register is set. Note that service requests are only produced when the bit is first set and thus any condition will only produce one service request. Accordingly, if a service request is desired every time an event occurs the status bit must be cleared between events.

For example, to generate a service request whenever an overrange condition occurs, bit 4 in the LCR Status Enable register needs to be set. (SENA 16 command). When overrange occurs, bit 4 in the LCR Status Byte is set. Since bit 4 in the LCR Status Enable Register is set, this will also set bit 3 in the Serial Poll Status Byte. In order for this to generate a service request, bit 3 in the Serial Poll Enable Register must be set (*SRE 8 command).

STANDARD EVENT STATUS BYTE	bit	name	usage
	0	OPC	Set by the OPC command when all measurements are complete
	1	unused	
	2	Query Error	Set on output queue overflow (Too many responses waiting to be transmitted.)
	3	unused	
	4	Execution err	Set by an out of range parameter, or non-completion of some command due a condition such as an incorrect operating mode.
	5	Command err	Set by a command syntax error, or unrecognized command
	6	URQ	Set by any key press
	7	PON	Set by power on

This status byte is defined by IEEE-488.2 (1987) and is used primarily to report errors in commands received over the communications interfaces. The bits in this register stay set once set and are cleared by reading them or by the *CLS command.

LCR STATUS BYTE	bit	name	usage
	0	Math Error	Set on a floating point error.
	1	A/D Error	Set when an A/D conversion fails.
	2	Overload	Set when the gain stage is overloaded.
	3	Underrange	Set when a measurement is below the nominal range of values for the present range.
	4	Overrange	Set when a measurement is above the nominal range of values for the present range.
	5	Out of Range	Set when the unit is unable to make a valid measurement on the current range.
	6	unused	
	7	mem err	the stored settings were invalid on power up.

The bits in this register are set when the corresponding event occurs and remain set until cleared by reading this status byte or by the *CLS command.

EXAMPLE PROGRAM 1

Using Microsoft C with the National Instruments GPIB card on the IBM PC.

To successfully interface the SR715/720 to a PC via the GPIB interface, the instrument, interface card, and interface drivers must all be configured properly. To configure the SR715/720, the GPIB address must be set using the switches SW2 on the rear panel.

Make sure that you follow all the instructions for installing the GPIB card. The National Instruments card cannot be simply unpacked and put into your computer. To configure the card you must set jumpers and switches on the card to set the I/O address and interrupt levels. You must run the program "IBCONF" to configure the resident GPIB driver for you GPIB card. Please refer to the National Instruments manual for information. In this example, the following options must be set with IBCONF:

Device name:	SR715/720
Device address:	same as SR715/720 switch settings
EOS character:	0AH (linefeed)
Terminate Read on EOS:	Yes

Once all the hardware and GPIB drivers are configured, use "IBIC". This terminal emulation program allows you to send commands to the SR715/720 directly from your computer's keyboard. If you cannot talk to the SR715/720 via "IBIC", then your programs will not run.

Use the simple commands provided by National Instruments. Use "IBWRT" and "IBRD" to write and read from the SR715/720. After you are familiar with these simple commands, you can explore more complex programming commands.

```
/****************************************************************************/
/*
Program to measure capacitance values with the LCR and read them using a National Instruments AT-GPIB
card. Internal bias is selected for C measurements (e.g. for electrolytic caps) so proper polarity must be ob-
served to avoid capacitor damage.

This program is written in Microsoft C version 5.1. Compile with \AL\c and link with the MCIB.OBJ module
supplied by National Instruments.

The LCR meter should be installed as device "SR720" using IBCONF.
*/

#include <stdio.h>
#include <stdlib.h>
#include <string.h>
#include <math.h>

#include <decl.h>   /* supplied by National Instruments in AT-GPIB package */

/* function prototype */
void main (void);
```

```
void main (void)
    {
    int lcr, bin;
    char string[80];
    double cmeas, dissp;

    if ((lcr = ibfind("720")) <=0) /* locate the lcr meter for communications */
        {
        printf ("? No LCR meter connected ?\n");
        exit (0);
        }

    ibwrt (lcr, "*RST", 4L);                         /* reset LCR meter */
    ibwrt (lcr, "MMOD1;PMOD3;FREQ0", 17L);           /* set triggered mode, measure C+D, Freq = 100 Hz */
    ibwrt (lcr, "outf1", 5L);                        /* concise ASCII output format */

    ibwrt (lcr, "BIAS1", 5L);                        /* turn internal bias on - it may be necessary to wait for
                                                        the capacitor to charge up here when measuring large
                                                        capacitors */
    ibwrt (lcr, "STRT;*WAI;XALL?", 15L);             /* take a measurement, wait until finished, and get
                                                        back the data. */

    printf ("Capacitance (uf) Dissipation\n");
    ibrd (lcr, string, 80L);                         /* get return string from LCR. */
    string[ibcnt] = 0;                               /* terminate received string. */
    sscanf (string, "%lf,%lf,%d", &cmeas, &dissp, &bin);    /* get C and Dissipation */
                                                     /* ( bin value not used) */
    printf ("%7.5e      %7.5e\n", cmeas*1.e6, dissp);  /* and print out results */

    ibwrt (lcr, "BIAS0", 5L);                        /* turn off bias */

    }
```

EXAMPLE PROGRAM 2

Using Microsoft C with the Capital Equipment Corp. (CEC) GPIB card on the IBM PC.

To successfully interface the SR715/720 to a PC via the GPIB interface, the instrument, interface card, and interface drivers must all be configured properly. To configure the SR715/720, the GPIB address must be set using the switches SW2 on the rear panel.

Make sure that you follow all the instructions for installing the GPIB card. The CEC GPIB card needs to be located in memory where it will not conflict with any other devices in the PC.

Once the hardware is configured, use "TRTEST". This terminal emulation program (supplied by CEC) allows you to send commands to the SR715/720 directly from your computer's keyboard. If you cannot talk to the SR715/720 via "TRTEST", then your programs will not run.

```
/************************************************************************************/
/*
This program demonstrates the use of the SR720's binary return format. A measurement is taken and
returned to the computer along with the type of reading (R,L,Q, etc.) and measurement status.

This program is written in Microsoft C version 5.1. The header file for the GPIB interface is ms-c488.h
(supplied by Capitol Equipment Corp). To compile this program, use CL/AL/c. Then link the resulting object
file with GPIB.OBJ (supplied by CEC).
*/

#include <stdio.h>
#include <string.h>
#include <stdlib.h>
#include <ms-c488.h>

#define sr720 17  /* GPIB address (make this equal to the SR720 address on SW2 */

/* function prototypes */
void main (void);
void InitGpib (void);
void TxGpib (int,char *);
void GetGpib (int);
void MakeTalk (int);
void StatCheck (int);

/* Global variables */
int status, length, count;
char recv[80];
unsigned char data[100];

/* Major and minor parameter types */
char mmaj[4][20] = {"Resistance", "Inductance", "Capacitance", "Capacitance"};
char mmin[4][20] = {"Q", "Q", "Dissipation", "Resistance"};
```

```
void main ()
    {
    float maj,min;
    int seg,mtype,errs;

    InitGpib ();
    TxGpib (sr720,"*RST;MMOD1;PMOD0");        /* reset LCR meter, triggered mode, set to auto
                                                 measurement mode */
    TxGpib (sr720,"OUTF2");                   /* verbose binary output */

    TxGpib (sr720,"STRT;*WAI;XALL?");         /* trigger a measurement, wait until it's over, then ask
                                                 for results */
    MakeTalk (sr720);                         /* make LCR a GPIB talker */
    count = 15;
    rarray (&status, &length, &count, data, &seg);  /* read output into array data[] */
                                              /* Check the programming section of the SR720 for
                                                 detailed information on binary return formats. */

    /* split up status byte to check for errors and measurement type */
    errs = data[2] & 15;        /* mask = 0000 1111 */

    mtype = data[2] & 48;   /* mask = 0011 0000 */
    mtype /= 16;                /* now mtype = 0000 00xx */

    switch (errs)
        {
        case 0:     printf ("Measurement ok (no errors).\n"); break;
        case 1:     printf ("? No measurement made ?\n"); break;
        case 2:     printf ("Measurement overloaded.\n"); break;
        case 4:     printf ("Underrange error.\n"); break;
        case 8:     printf ("Overrange error.\n"); break;
        case 15:    printf ("Out of range error.\n"); break;
        default:    break;
        }

    /* transfer major parameter bytes(4) to create a single precision FP number */
    memcpy (&maj, &data[3], 4);                  /* store four bytes as a floating point number */

    /* now do the same for the minor parameter. */
    memcpy (&min, &data[8], 4);

    printf ("%s = %7.4e, %s = %7.5e.\n", mmaj[mtype], maj, mmin[mtype], min);

    }
```

```
/* ************************************************************** */
void InitGpib (void)        /* initialize the CEC GPIB card as controller */
        {
        int my_address, system_controller;
        unsigned seg;

        /* find cec card address */
        for ( seg=0x4000 ; seg < 0xF000 ; seg += 0x400 )
                { if ( (peek (seg,50) == 'C') && (peek (seg,51) == 'E') && (peek (seg,52) == 'C') ) break; }

        if ( pc488_seg(seg))
                { printf ( " no gpib card installed\n"); exit(0); }

        my_address = 21;
        system_controller = 0;
        initialize (&system_controller, &my_address);    /* init controller (CEC) function */
        transmit (&status, "IFC UNT UNL DCL REN");    /* device clear and remote enable */
        }
/* ************************************************************** */
void MakeTalk (int address)    /* make device at address a talker */
        {
        char cmd[25];

        sprintf (cmd, "UNT UNL MLA TALK %d", address); /* make the talk command string */
        transmit (&status, cmd);                       /* send the talk command string */
        StatCheck (address);                           /* check interface status */
        }
/* ************************************************************** */
void TxGpib (int address,char *command)              /* transmit command to address */
        {
        char t_string[150];
        int result;

        result = sprintf (t_string, "UNT UNL MTA LISTEN %d DATA '%s' END", address, command);
        transmit (&status, t_string);                /* can also use the send () function in the CEC library
                                                        */
        StatCheck (address);
        }
/* ************************************************************** */
void GetGpib (int address)    /* get an answer from device at address */
        {
        char r_string[40], temp[80];

        sprintf (r_string, "UNT UNL MLA TALK %d", address);
        transmit (&status, r_string);                /* make device a talker */
        StatCheck (address);                         /* check status for ok */
        strcpy (temp, "                    ");        /* init answer string to null */
        receive (&status, &length, temp);            /* receive answer */
        StatCheck (address);                         /* check status for ok */
        strcpy (recv, temp);                         /* copy receive string to global strinb recv[] */
        }
```

```
/* ***************************************************************** */
        void StatCheck (int address)                    /* check the gpib status and exit if error */
        {
        if (status != 0 && status != 32)
                { printf ("Error at device %d : status = %d",address,status); exit (0); }
        }
/* ***************************************************************** */
```

EXAMPLE PROGRAM 3

Using Microsoft C with the Capital Equipment Corp. (CEC) GPIB card on the IBM PC.

To successfully interface the SR715/720 to a PC via the GPIB interface, the instrument, interface card, and interface drivers must all be configured properly. To configure the SR715/720, the GPIB address must be set using the switches SW2 on the rear panel.

Make sure that you follow all the instructions for installing the GPIB card. The CEC GPIB card needs to be located in memory where it will not conflict with any other devices in the PC.

Once the hardware is configured, use "TRTEST". This terminal emulation program (supplied by CEC) allows you to send commands to the SR715/720 directly from your computer's keyboard. If you cannot talk to the SR715/720 via "TRTEST", then your programs will not run.

```
/**********************************************************************************/
/*
This program will sort resistors into eight bins of tolerances between 0.1% and 0.8%, and provide a table of
results.

This program is written in Microsoft C version 5.1. The header file for the GPIB interface (ms-c488.h) is
supplied by CEC.

To compile this program, use the command: CL/AL/c prog.c. Then link the resulting object file with GPIB.obj
(supplied by CEC). Ansi.sys must be installed in config.sys for proper screen format. */

#include <ms-c488.h>
#include <stdio.h>
#include <conio.h>
#include <stdlib.h>
#include <string.h>

#define lcr   17     /* GPIB address for LCR meter as set by SW2 on the rear panel */

/* function prototypes */
void InitGpib (void);
void TxGpib (int, char*);
void GetGpib (int);

void Clear (void);
void GetSpace (void);
void Erase (int, int);
void Printxy (int, int, int, char *);
void Gotoxy (int, int);

/* global variables */
char recv[40];
int status, length;

int bin[10];                /* eight tolerance bins plus QDR and general fail bins */
```

```
/* Parameters for 10Kohm resistors sorted into 0.1% increments */

/* bin #      1, 2, 3, 4, 5, 6, 7, 8, QDR */
double nom[9] = {1.0e4, 1.0e4, 1.0e4, 1.0e4, 1.0e4, 1.0e4, 1.0e4, 1.0e4,  0.00015},
ulim[8] = { 0.1, 0.2, 0.3, 0.4, 0.5, 0.6, 0.7, 0.8 },
llim[8] = {-0.1, -0.2, -0.3, -0.4, -0.5, -0.6, -0.7, -0.8 };

void main(void)
    {
    int i, b;
    double rmeas, q;
    char string[80];

    InitGpib();                     /* init GPIB controller */
    TxGpib (lcr, "*RST;MMOD1;PMOD1;BCLR");     /* reset LCR, triggered mode, measure R and Q, clear
                                                all bins */
    /* set up the bins */
    Clear();                        /* clear screen */
    printf ("Bin values for the LCR:\n\n");
    printf (" Bin #     Nominal value     Tolerances\n");
    for (i=0;i<8;i++)
        {
        /* send nominal bin value, upper and lower limits to LCR */
        sprintf (string, "BNOM%d,%lf;BLIM0,%d,%lf;BLIM1,%d,%lf\n", i, nom[i], i, ulim[i], i, llim[i]);
        TxGpib (lcr, string);                   /* send nominal, upper and lower limit of bin i */
        /* print limits on the screen also */
        printf ("   %d           %7.1lf        +%2.1lf/%2.1lf\n", i, nom[i], ulim[i], llim[i]);
        }

    /* Now send nominal QDR fail value to the LCR and the screen*/
    sprintf (string, "BNOM8,%lf", nom[8]);
    TxGpib (lcr, string);
    printf("\nQDR fail value = %7.5lf\n", nom[8]);

    GetSpace();

    TxGpib(lcr, "BING1");    /* turn on binning */
    Clear();                 /* clear screen */

    /* measurement cycle */
    while (1)
        {
        Printxy (2,0,0, "Insert resistor into the LCR fixture ('q'to quit).\n");
        GetSpace();
        Erase(2,1);
        printf ("Measuring...\n");

        TxGpib (lcr, "STRT;*WAI;XALL?");         /* start a measurement, wait until finished, query the
                                                  results */
        GetGpib (lcr);                           /* get resistance, q, and bin values */
        sscanf (recv, "%lf,%lf,%d", &rmeas, &q, &b); /* scan received string for values */

        Erase(10,2);
        sprintf (string, "Resistor measures %7.2lf ohms. Q = %7.5lf\n", rmeas,q);
```

```
        Printxy(10,0,0,string);

        if (b==9) printf ("Resistance out of bin tolerances! FAILED. \n");
        else if (b==8) printf ("Q is out of tolerance\n");
        else   printf ("Value falls into bin %d.\n", b);

        bin[b]++;            /* increment number of elements in that bin */

        /* Now print out updated table of bins */
        Gotoxy (20,0);
        printf ("bin  0      1      2      3      4      5      6      7      QDR Fail\n");
        printf ("        ");
        for (i=0; i<10; i++) printf("%d      ", bin[i]);
        printf("\n");
        }
    }
/* *********************************************************************** */
void InitGpib (void)      /* initialize the CEC GPIB card as controller */
    {
    int my_address, system_controller,seg;

    /* Find the CEC card address */
    for (seg=0x4000;seg<0xF000;seg+=0x400)
        { if ((peek(seg,50) == 'C') && (peek(seg,51) == 'E') && (peek(seg,52) == 'C'))break; }
    if (pc488_seg(seg))
        { printf("No Gpib Card found.\n"); exit(0); }

    my_address = 21;
    system_controller = 0;
    initialize (&system_controller, &my_address);      /* init controller (CEC) function */
    transmit (&status, "IFC UNT UNL DCL REN");    /* device clear and remote enable */
    }
/* *********************************************************************** */
void TxGpib (int address, char *command)              /* transmit command to address */
    {
    char t_string[100];
    int result;

    result = sprintf (t_string, "UNT UNL MTA LISTEN %d DATA '%s' 10", address, command);
    transmit (&status, t_string);                      /* can also use the send () function in the CEC library
                                                       */
    }
/* *********************************************************************** */
void GetGpib (int address)      /* get an answer from device at address */
    {
    char r_string[40], temp[80];

    sprintf (r_string, "UNT UNL MLA TALK %d", address);
    transmit (&status, r_string);                      /* make device a talker */
    strcpy (temp, "                     ");            /* init answer string to null */
    receive (&status, &length, temp);                  /* receive answer */

    if (status==8) { printf("Timeout error.\n"); exit(0); }
```

```
          strcpy (recv, temp);                                    /* copy receive string to global strinb recv[] */
          }
/* ***************************************************************** */
void Clear (void)   /* Clear the screen (requires ansi.sys in config.sys file)*/
          {
          putch(27); printf ("[2J");
          }
/* ***************************************************************** */
void GetSpace (void)     /* Wait for space key */
          {
          int ch;

          Printxy (25,30,30,"<Space> to continue ");

          do
               {
               ch = getch ();
               if ((ch == 'q')||(ch =='Q'))
                       { flushall(); exit(0); }
               }
          while(ch != ' ');
          Erase(25,1);
          }
/* ***************************************************************** */
void Erase (int row, int num)   /* Erase num rows starting at row  (requires ansi.sys)*/
          {
          int i;

          for (i = 0; i < num; i++,row++)
               {
               Gotoxy (row,0);
               putch(27);
               printf("[K");
               }
          }
/* ***************************************************************** */
void Printxy (int x, int y, int n, char *msg)                /* print msg at (x,y) erasing n chars first */
          {
          int i;

          Gotoxy (x,y);
          for (i = 0; i <= n; i++) printf (" ");
          Gotoxy (x,y);
          printf (msg);
          }
/* ***************************************************************** */
void Gotoxy (int row, int col)    /* place the cursor at (row,col) (requires ansi.sys) */
          {
          putch(27); printf("[%d;%dH", row, col);
          }
```

5-22

EXAMPLE PROGRAM 4

IBM PC, IBM BASIC using the RS232 interface

In this example, the IBM PC serial port COM1: is used at 9600 baud. Configure the SR715/720 to 9600 baud, 8 bits, no parity before running the program. The RS232 configuration is set using switch SW1 on the rear panel.

```
10 ' Sample program to trigger a measurement and read the results from the LCR
20 '
30 'Open com1 port for 9600 baud, 8 bits, no parity, no handshaking
40 OPEN "com1:9600,n,8,2,cs,ds,cd" AS #1
50 PRINT #1,"   "  'clear out com port
60 '
70 ' reset LCR, set to triggered mode, read C and R, brief ascii data
80 PRINT #1,"*RST;MMOD1;PMOD4;OUTF1"
90 '
100 PRINT "Resistance (ohms)   Capacitance (uF)"
110 PRINT #1,"STRT;*WAI" 'take a reading, wait til finished before proceeding
120 PRINT #1,"XMAJ?"   'capacitance
130 INPUT #1,VAL1$
140 PRINT #1,"XMIN?"   'resistance
150 INPUT #1,VAL2$
160 PRINT "   "VAL2$"   "VAL1$
170 END
```